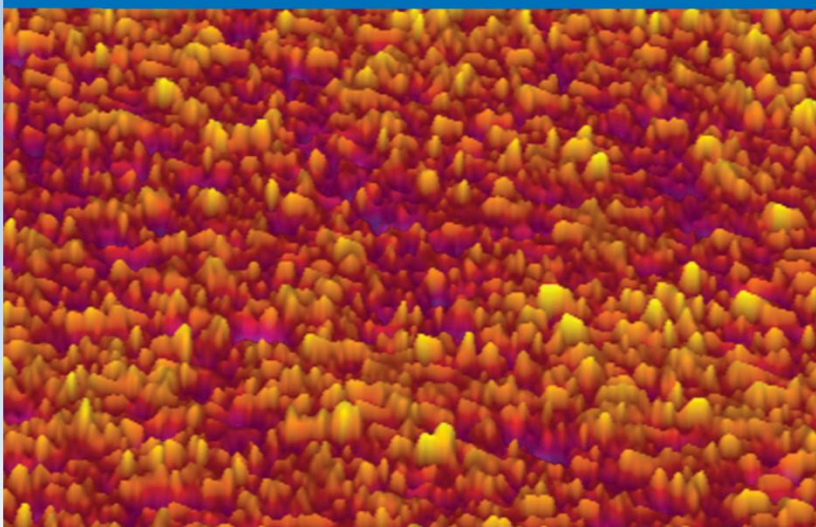




DektakXT

Stylus Profiler

User Manual

DEKTAKXT

STYLUS PROFILER

USER MANUAL



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May 31, 2011

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SAFETY

The DektakXT™ system may be set up and operated only in accordance with the instructions outlined in this manual. In the chapters that follow, the messages below indicate that special vigilance is required.

**CAUTION**

Whenever you see a Caution note, there is a possibility that data will be lost, or there is some specific action that you must perform for the system to work properly.

**WARNING**

Whenever you see a Warning note, there is the possibility of personal injury or equipment damage.

SAFETY FEATURES

Several features of the DektakXT system ensure operator safety.

Red Emergency Off Button

The DektakXT system is equipped with a red EMERGENCY OFF button, located on the EMO box (see [Figure 1-1](#)). This unit may be placed in any convenient and readily accessible location.

Pressing the EMERGENCY OFF button shuts off DC power to the system devices, excluding the computer, monitor, and power supply adapter. The 24 VDC control circuit in the EMO Box also remains energized.

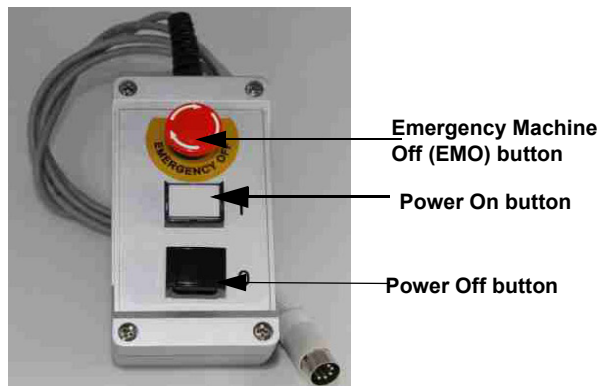
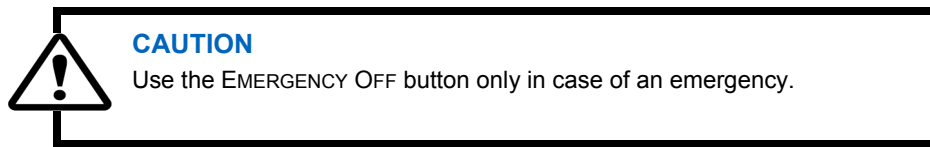


Figure 1-1: EMO Box



White Power On Button and Black Power Off Button

The DektakXT system is equipped with a white POWER ON button and a black POWER OFF button. These buttons are located next to the red EMERGENCY OFF button on the EMO Box (see [Figure 1-1](#)).

Pressing the POWER ON button provides DC power to all system devices but the computer, monitor, and power supply adapter.

Pressing the POWER OFF button shuts off DC power to all system devices but the computer, monitor, and power supply adapter. The 24 VDC control circuit in the EMO Box also remains energized.

SAFETY PRECAUTIONS

The DektakXT system is designed to minimize potential health and safety hazards during normal operation and routine maintenance activities. As with any mechanical system that uses electrical energy and compressed air, it contains some physical and electrical hazards. You should be aware of these potential hazards and the controls used to minimize them. Review this section and contact Bruker if you have any questions on environmental, health, or safety-related issues associated with the system.

Potential safety hazards associated with the system are clearly identified in this manual. In addition, warning and safety labels have been placed on the system where there exists a potential for personal

injury or damage to the system. The following table illustrates each label, describes its meaning, and indicates where it appears on the system.

Table 1-1: Warning, Safety, and Compliance Labels

Illustration	Meaning	Location on System
	If shock indicator is red, proceed as directed on red arrow.	Shipping box that holds the DektakXT profiler
	Only authorized personnel may service this equipment. See this manual for safety information.	Right face of EMO Box
	Indicates that only 110 - 120 Volts AC may be used.	Back of computer, near power cord port
	Indicates that only 220 - 240 Volts AC may be used.	Back of computer, near power cord port
	Pinch point hazard. Keep hands clear.	Left face of scan stage
	Warns against non-compliance with safe waste disposal procedures for electrical and electronic equipment.	Lower right face of EMO Box
	Indicates that system complies with China RoHS environmental standards regarding toxic or hazardous substances or elements.	Rear cover
	Indicates that system complies with European Compliance (CE)	Lower left face of EMO box

SAFETY AND HEALTH HAZARDS

Although the DektakXT system has been designed with safety in mind, it does contain some inherent potential hazards. Physical hazards associated with operating the equipment are discussed in this section.

Mechanical Hazards

Mechanical hazards exist in the systems wherever moving parts are located, such as slides. Protection against most of the mechanical hazards in the DektakXT system is provided in the form of a hood and system base. Wherever possible, physical guards have been placed around moving parts to prevent personnel from contacting them. The exceptions are the areas around and above the X-Y stage. These areas, however, do not contain pinch-point hazards.

Some maintenance tasks may require removal of the hood and system base. In these cases, safe work practices, including use of lockout procedures for electricity, pressure (pneumatic system) or other applicable hazards, should be followed. Only trained service personnel should perform maintenance activities that require mechanical motion while the hood and base are removed.

Pressure Hazards

Pressure hazards exist due to the difference in kinetic energy of a gas within a container or piping system and the surrounding environment. If a sudden breach of a gas line or a pressurized container were to occur (for example, a gas delivery line bursts), the pressure differential between the gas in the line and the surrounding atmosphere will cause the gas to be forcefully expelled into the surrounding atmosphere. This can cause physical injuries due to particles flying outward with extremely high speed.

The DektakXT system uses compressed clean dry air (CDA) to operate the optional vibration isolation table. It is designed to use CDA at the typical house-supplied pressures of 50 psi. The CDA fittings or components of the pneumatic system should be adjusted only after appropriate release of air-line pressure. As with electrical and mechanical tasks, maintenance activities involving the air lines should occur only after appropriate pressure lockout procedures have been implemented (see [General Lockout/Tagout Procedures](#) in the section that follows).

INSTALLATION AND MAINTENANCE SAFETY ISSUES

Certain installation activities require attention to special safety hazards in addition to the overall system hazards discussed in the [Safety and Health Hazards](#) section above. The installation of the systems requires connection and adjustment of electricity and pressurized air lines. These types of activities require knowledge and use of lockout/tagout procedures.

Maintenance procedures often present greater hazards to personnel than normal production activities due to the need to defeat safety features in order to access the equipment. The following sections present general information on some of the key safety-related procedures or actions that maintenance personnel should follow when servicing the DektakXT system.

General Lockout/Tagout Procedures

This section describes general lockout/tagout procedures for electrical systems and pressurized air lines. Contact your internal safety and health representative for more detailed procedures for your facility, as well as for training and authorization/certification requirements.

Lockout Procedure

- 1 Notify all affected and other persons of intended lockout.
- 2 Turn off the computer following the normal shutdown procedure.
- 3 Unplug the first cord on the power supply adapter from its receptacle on the signal processor on the back of the DektakXT stylus profiler.
- 4 Unplug the second cord on the power supply adapter from its wall outlet.
- 5 Place the power supply adapter with its two disconnected cords in a secure location. This is the equivalent of a lockout/tagout procedure on a more complex system.
- 6 Close the air regulator toggle switch below the vibration isolation table.
- 7 Dissipate any residual pressure following the appropriate dissipation procedure (for example, opening a bleed valve).
- 8 Verify that all personnel are clear of the hazard zone.
- 9 Attempt to restart the equipment. If properly locked out the equipment should not be able to be started.
- 10 Use a voltmeter and make voltage measurements to verify that all electrical sources have been locked out. If properly locked out, no voltage should be present. Check the reading on supply line pressure gauges to verify that no pressure exists within the system. If properly locked out, no pressure should exist.
- 11 Perform maintenance work.

Returning the System to Operation

- 1 Verify that all personnel, materials, tools, and test equipment are clear of the hazard zone.
- 2 Plug the first cord on the power supply adapter into its receptacle on the signal processor on the back of the DektakXT stylus profiler.
- 3 Plug the second cord on the power supply adapter into a wall outlet.
- 4 Open the air regulator toggle switch to repressurize the vibration isolation table.
- 5 Turn on the computer following the normal startup procedure.
- 6 Notify all affected and other persons that the lockout has been cleared and the equipment is back in operation.

Electrical Task Classification

Each task involving electrical operations is evaluated for severity and classified according to the criteria outlined in Table 1-2. These criteria categorize electrical hazards into four types, ranging from Type 1 (de-energized) to Type 4 (fully energized and exposure required). Lockout/tagout requirements, including training requirements, are based on the type of hazard present.

- All operator tasks are classified as Type 1 or 2.
- Only qualified service personnel should perform Type 3 or 4 tasks, following established Bruker service policies.

Table 1-2: Classification of Operator Tasks

Task Type	Description
Type 1	Equipment is fully de-energized
Type 2	Equipment is energized. Energized circuits are covered or insulated.
Type 3	Equipment is energized. Energized circuits are exposed and inadvertent contact with uninsulated energized parts is possible. Potential exposures are no greater than 30 volts rms, 42.4 volts peak, 60 volts DC or 240 volt-amps in dry locations.
Type 4	Equipment is energized. Energized circuits are exposed and inadvertent contact with uninsulated energized parts is possible. Potential exposures are greater than 30 volts rms, 24 volts peak, 60 volts DC, or 240 volt-amps in dry locations. Potential exposures to radio-frequency currents, whether induced or via contact, exceed certain limits.

NOTE – No routine tasks for the DektakXT system are classified as Type 4.

During any troubleshooting or maintenance activities that are performed while the DektakXT system is operating, the technician should always be able to easily reach the EMERGENCY OFF button on the EMO Box (see [Figure 1-1](#)). In case of an emergency, the technician can press the EMERGENCY OFF button to immediately stop the system.

In some circumstances, it is advisable to have two service personnel working on a system at the same time. This ensures that one person will always have access to the EMERGENCY OFF button.



SYSTEM OVERVIEW

The DektakXT[®] stylus surface profiler is an advanced thin and thick film step height measurement tool. In addition to profiling surface topography and waviness, the DektakXT system measures roughness in the nanometer range. Available with a standard manual sample-positioning stage (see [Figure 2-1](#)) or an optional automatic X-Y or theta stage (see [Figure 2-3](#)), it provides a step-height repeatability of 5 Å (<0.6 nm).

In addition to taking two-dimensional surface profile measurements, the DektakXT system can produce three-dimensional measurements and analyses when equipped with the 3D Mapping Option.

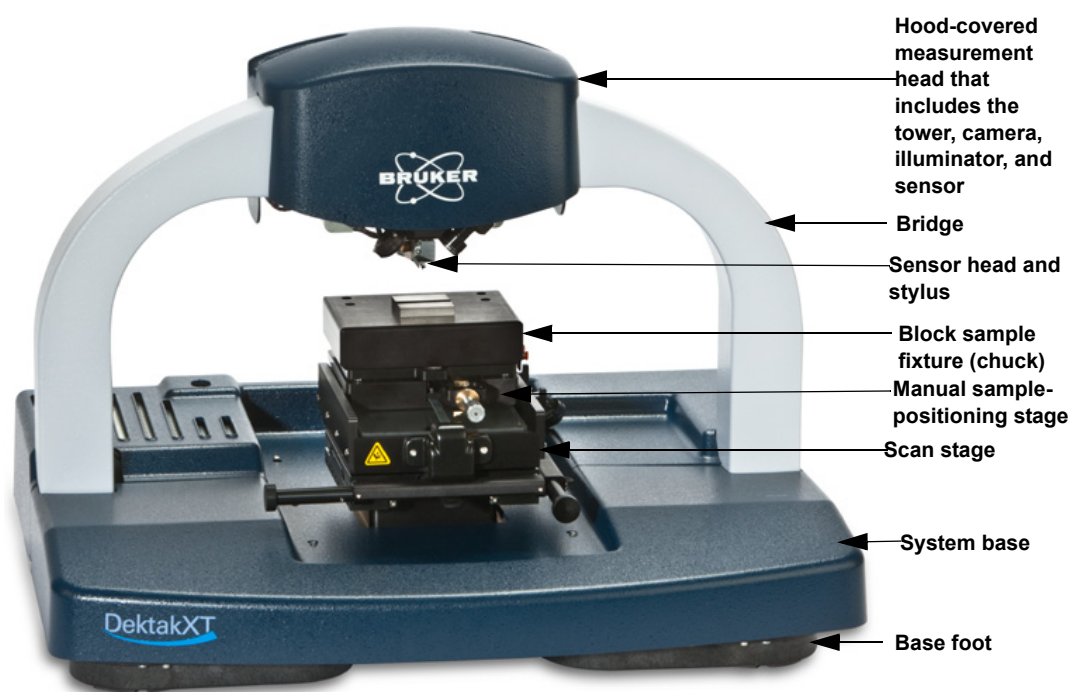


Figure 2-1: DektakXT Stylus Profiler with the Standard Manual X-Y Sample-Positioning Stage

HOW THE SYSTEM WORKS

The DektakXT system takes measurements electromechanically by moving a diamond-tipped stylus over the sample surface according to a user-programmed scan length, speed, and stylus force. The stylus is linked to a Linear Variable Differential Transformer (LDVT), which produces and processes electrical signals that correspond to surface variations of the sample. After being converted to digital format, these surface variations are stored for display and analysis.

The Vision64 application calculates and displays the results of user-selected analytical functions for measuring surface texture and other parameters to characterize the profile data. For example, the Ra (average roughness) analytical function—the most commonly used international parameter of roughness—calculates the arithmetic average deviation from the mean line within the assessment length. If there is an active database, selected analytical functions are logged to it during each measurement.

STAGE CONFIGURATIONS

The DektakXT stylus surface profiler comes in the following stage configurations:

- **The standard 2-D DektakXT system**, which includes a two-axis, manual sample-positioning stage with 101.6 x 101.6 mm (4 x 4 inches) of X-Y translation, manual leveling, two-point programmable or cursor software leveling, and manual theta rotation (see [Figure 2-2](#)). This standard stage accommodates samples up to 50 mm (1.9 inches) thick and performs long scans of 55 mm (2.16 inches). It provides ± 50.8 mm (2 inches) of X-Y translation as well as manual theta positioning (see [Figure 2-3](#)). The standard system is available with 50 mm (1.97 inch), 100 mm (3.94 inch), and 150 mm (5.90 inch) wafer alignment pins, along with one of the following sample fixtures (chucks):
 - 101 mm (4-inch) square base platform with no vacuum capability
 - Ceramic vacuum
 - Dedicated photo voltaic vacuum

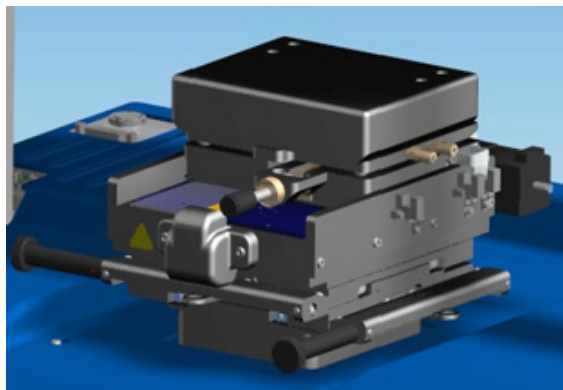


Figure 2-2: Standard Manual Sample-Positioning Stage with Square Base Platform Fixture

- **The 3D Mapping and Automation Options**, which include an X-Y auto sample-positioning stage (see [Figure 2-3](#)). In addition to 3D mapping (see [Figure 2-15](#)), these options provide automation and programmability of up to 200 sites on samples of up to 150 mm (5.90 inches) in diameter. The X-Y auto sample-positioning stage includes one of the following sample fixtures (chucks):
 - 50 mm to 76 mm (2 to 3 inch) wafer vacuum
 - 101 mm to 152 mm (4 to 6 inch) wafer vacuum
 - Dedicated 203 mm (8-inch) wafer vacuum
 - Ceramic vacuum
 - Dedicated photo voltaic vacuum

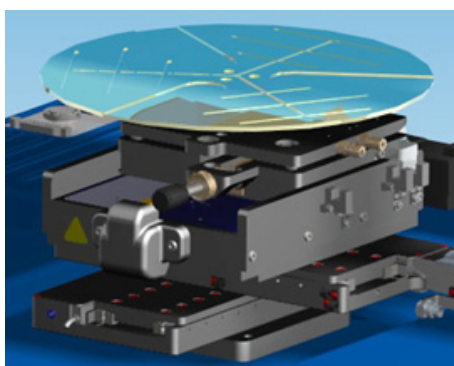


Figure 2-3: X-Y Auto Stage with Wafer Vacuum Sample Fixture (Chuck)

PROFILER COMPONENTS

As shown in [Figure 2-1](#), the DektakXT stylus surface profiler system contains all of the mechanical, electrical, and optical components for sample positioning, sample viewing, and scanning/measurement. As described in [Stage Configurations on page 2-2](#), the system can be configured with a manual or X-Y auto stage. Its sturdy single-arch bridge design reduces sensitivity to adverse environmental conditions.

Measurement Head

The hood-covered measurement head shown in [Figure 2-1](#) houses a USB video camera and an LED illuminator to assist the operator in feature location and stylus centering. The live video output of the camera provides feedback to the operator during a scan measurement.

The measurement head also includes a sensor head that magnetically holds the stylus assembly and contains the feedback mechanisms required to track stylus movement as it rides over the sample surface.

**WARNING**

Do not remove the hood and attempt to service the components of the yourself. Instead call Bruker Customer Service. Failure to heed this warning can result in damage to delicate equipment.

Sensor Head and Stylus Assembly

A diamond-tipped stylus (see [Figure 2-3](#)) attached to the sensor head permits accurate two-dimensional surface profiler measurements in a wide range of applications. In standard configuration, user-programmable stylus force from 1 mg to 15 mg allows profiling on soft or hard surfaces.

A variety of available stylus tip sizes are available to fill a broad range of measurement applications. Each tip comes in its own protective case.

NOTE – The DektakXT system comes with a stylus exchange tool that allows you to safely exchange one stylus for another without damaging the delicate tip.

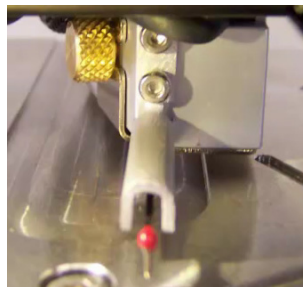


Figure 2-4: Sensor Head and Stylus Assembly

Sample-Positioning Stage

Available sample-positioning stages and sample fixtures (chucks) are discussed in [Stage Configurations on page 2-2](#).

Scan Stage

The direct-drive scan stage accelerates measurements by reducing the time between scans. This allows for the generation of large 3D maps or long scans for measuring stress.

Electronics

The DektakXT system includes a power supply adapter with an input voltage 100 - 240 VAC (see [Figure 2-5](#)). This unit sends power to the various system components.

A signal processor provides monitoring and control of the LVDT signal, stylus force coil, stage motor, and LED illumination (see [Figure 2-6](#)). An integrated cable connector panel handles system input, output, and power signals.

Power demand is 110 VA maximum with a standard outlet power connection.



Figure 2-5: Power Supply Adapter



Figure 2-6: Signal Processor

Base Feet

The standard urethane polymer base feet (see [Figure 2-7](#)) help isolate the system from the surrounding vibrational environment.



Figure 2-7: Standard Base Foot

The optional passive pneumatic isolation feet (see [Figure 2-8](#)) accept compressed air or nitrogen. These feet can be used in place of a large vibration isolation system.



Figure 2-8: Isolation Base Foot

Environmental Enclosure

The acrylic environmental enclosure (see [Figure 2-9](#)) protects the sample and scan area from adverse outside influences such as noise, vibrations, dust, and air currents. The front door lifts to provide sample access. The system should always be operated with the enclosure door closed.



Figure 2-9: Environmental Enclosure with the Door Closed

EMO Box

An Emergency Machine Off box (EMO Box) includes POWER OFF and POWER ON buttons, along with an EMERGENCY OFF button (see [Figure 2-10](#)). The EMERGENCY OFF button cuts off power to the DektakXT system but leaves power on to the computer and monitor. After the EMERGENCY OFF button has been depressed, the power cannot be returned to the system until it has been released. This is accomplished by turning it clockwise by one-eighth turn.

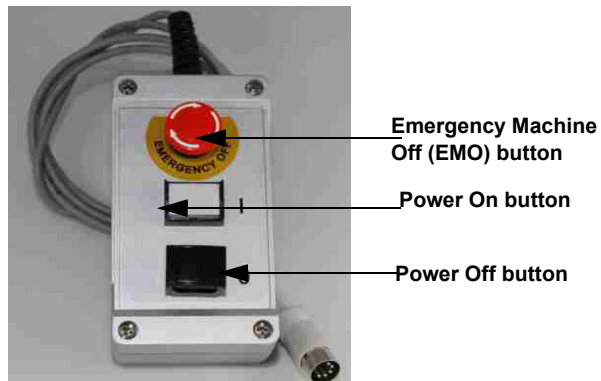


Figure 2-10: EMO Box

COMPUTER AND SOFTWARE

The DektakXT system can include the optional Dell™ computer, keyboard, mouse, and DVD drive. If you prefer to use your own preferred computer it must fill the following requirements:

- The computer must be capable of running the Windows7 operating system
- The monitor must have a 6 x 9 aspect ratio and minimum display resolution 1920 x 1080.

The pre-loaded Vision64 measurement and analysis software (see [Figure 2-11](#)) has 64-bit parallel-processing architecture. It allows you to adjust the system illumination, position a sample under the stylus, take single-scan or automated measurements (see [Figure 2-12](#)), calculate analytical functions, apply analyses and filters, and perform special operations, such as comparing the analytical results from multiple scans. For an introduction to Vision64, see [Chapter 5](#) of this manual. For full instructions on using the Vision64 software, see the DektakXT online Help.

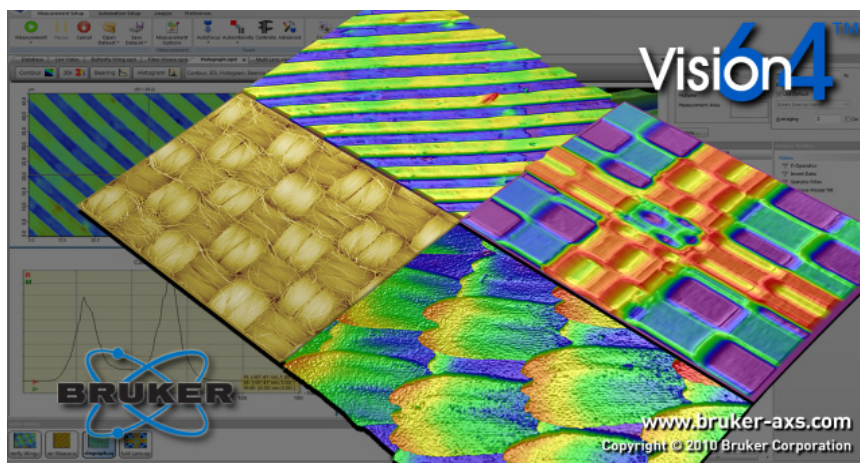


Figure 2-11: The Vision64 Welcome Screen

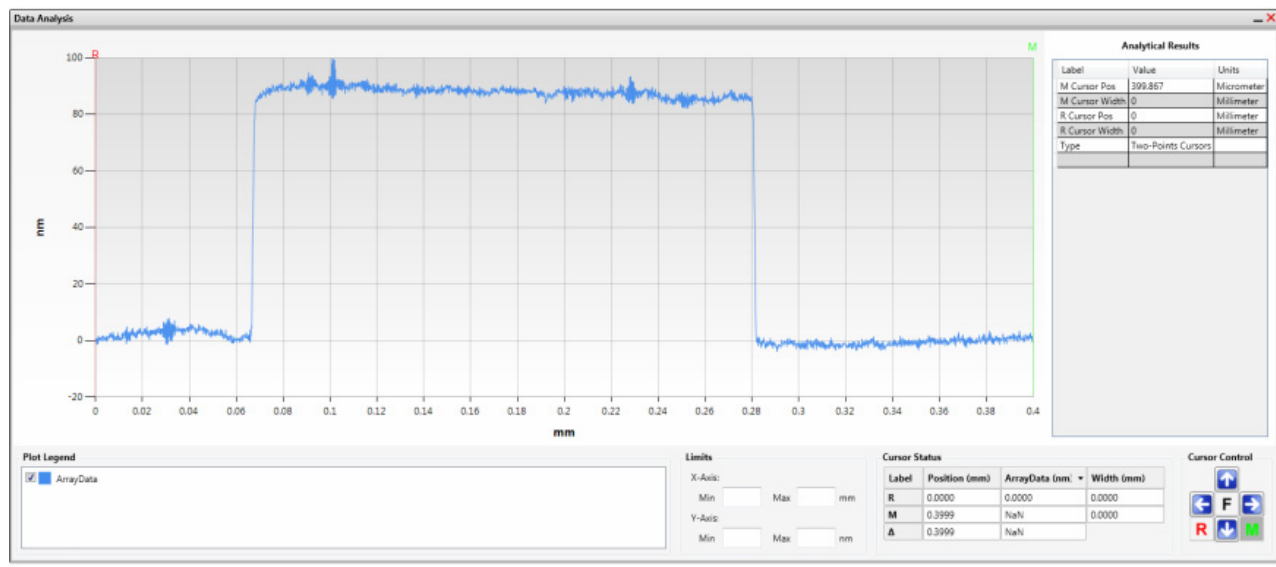


Figure 2-12: Output Display for a Single-Scan Measurement

OPTIONS AND ACCESSORIES

A number of options and accessories are available for the DektakXT system, including:

- A video monitor that provides a 23-inch, high-resolution, flat-panel color display (see [Figure 2-13](#)). It shows programs and graphics in full color, along with a color video image of the sample surface from the USB camera in the tower assembly.

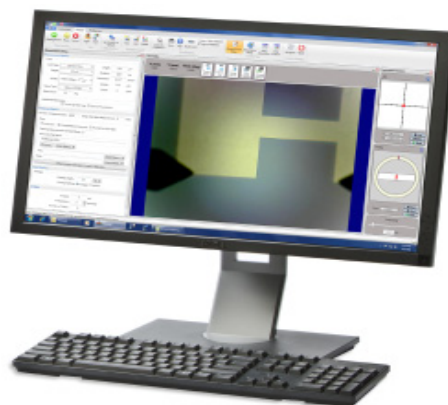


Figure 2-13: Video Monitor

- The X-Y auto stage described in [Stage Configurations on page 2-2](#).
- A broad line of calibration standards (see [Figure 2-14](#)).



Figure 2-14: Step Height Standard

- A variety of styli for measuring fine surface features and softer samples.
- Stress Measurement for calculating tensile or comprehensive stress on processed wafers.
- The 3D Mapping Option that enables true 3D-mapping (see [Figure 2-15](#)), calculates the bearing ratio, and performs many other analyses.
- 200-mm (7.8 inch) data-stitching software for increasing the scan length to 150 mm or longer with multiple stitching operations (available only on systems that include the X-Y auto stage).

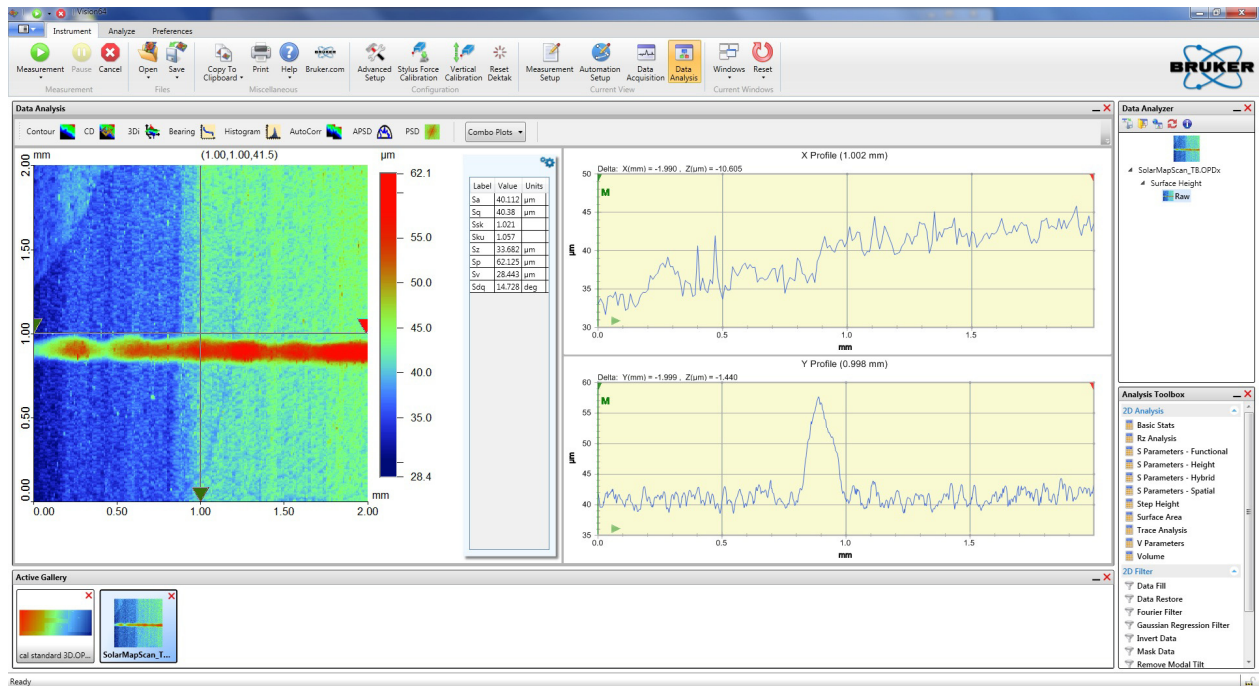


Figure 2-15: 2D Contour Plot Generated with the 3D Mapping Option



BASIC OPERATIONS AND MAINTENANCE

This chapter describes the basic use of your DektakXT stylus surface profiler, including the software procedures that involve profiler control. For instructions regarding other software procedures, see Chapter 5 of this manual and the Vision64 online Help.

POWERING UP THE SYSTEM

The following steps include all possible startup contingencies. Normally you can simply press the white ON button on the EMO Box, turn on the computer and monitor, and then start the Vision64 software.

To power up the DektakXT system:

- 1 Verify that the cable from power supply adapter is connected to a wall outlet.
- 2 Verify that all USB cables are connected.
- 3 Verify that the software key is installed in a USB port of the computer (see [Figure 3-1](#)). (The software key is shipped inside the Vision64 CD case.)



Figure 3-1: Software Key in a USB Port

- 4 Verify that the red Emergency Off button on the EMO Box is in the On (popped-up) position. If it is not, release it by rotating it clockwise until it pops up (see [Figure 3-2](#)).

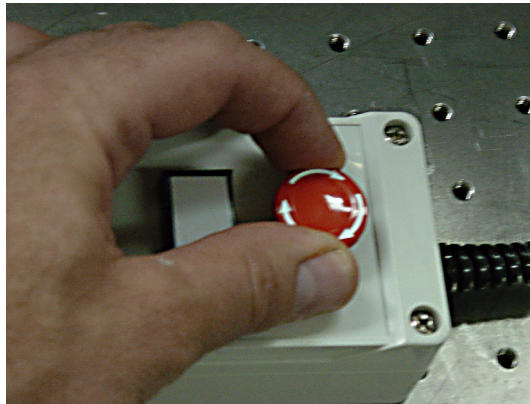


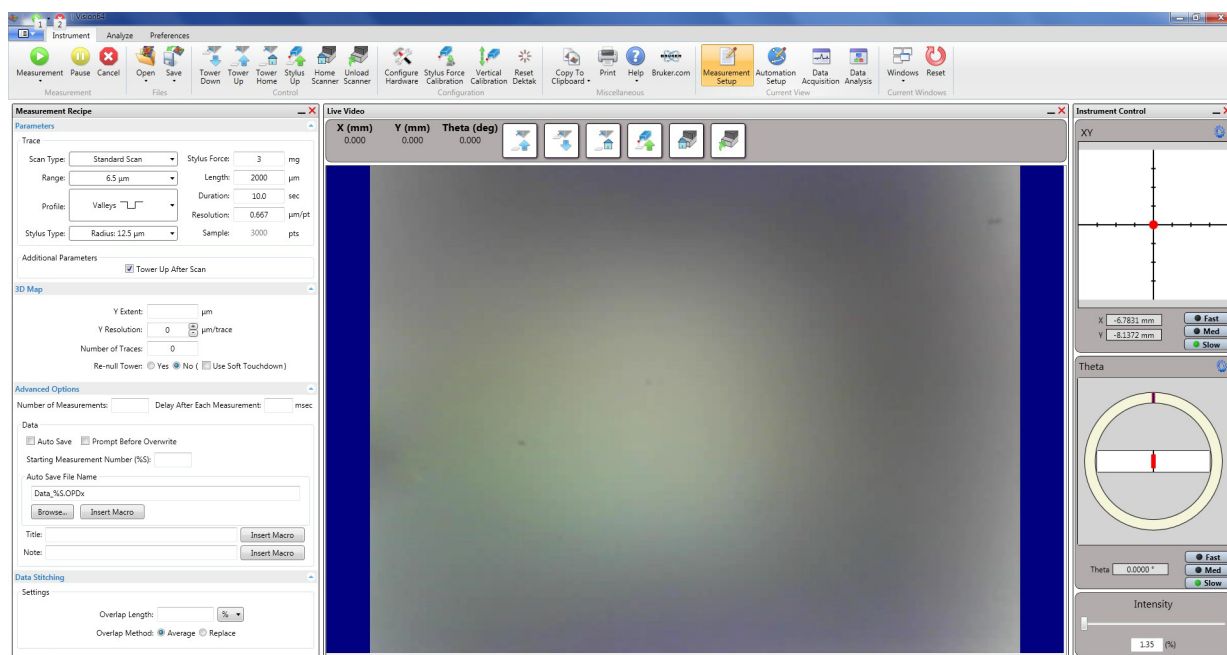
Figure 3-2: Releasing the Red Emergency Off Button on the EMO box

- 5 Press the white ON button on the EMO Box. After you do this, the following events occur:
 - The white ON button on the EMO box illuminates (see [Figure 3-3](#)).



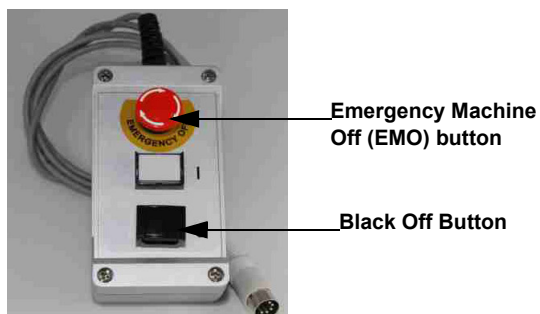
Figure 3-3: EMO Box with Illuminated On Button

- All system devices are powered up with the exception of the computer and monitor.
 - The light bar at the back of the profiler illuminates.
 - The red LED lights on the scan stage limit switches illuminate.
- 6 Press and release the power button on the front of the computer.
 - 7 Turn on the monitor and power up the computer.
 - 8 Select **Start > Vision64** or click the Vision64 application button  on the desktop or task bar. As the software launches, the following events occur:
 - The tower assembly moves to its upper limit. The system stops with the stylus in the Tower Up position.
 - The scan stage initializes. You can now safely position the sample beneath the stylus.
 - The Vision64 Welcome screen appears, followed by the Vision64 **Instrument** tab, which includes the DektakXT Live Video Display (see [Figure 3-4](#)).
 - 9 Allow the system to warm up for approximately 15 minutes before taking a scan measurement.



POWERING DOWN THE SYSTEM

IMPORTANT SAFETY INFORMATION! The DektakXT system is equipped with a red EMERGENCY OFF button located on the EMO Box connected to the back of the profiler (see [Figure 3-4](#)). You may place this box in any convenient and readily accessible location. Pressing the EMERGENCY OFF button immediately shuts off power to all system components, excluding the computer, monitor, and power supply adapter. The 24 VDC control circuit in the EMO Box also remains energized. After you power down the system via the EMO box, you must exit Vision64, shut down the computer, and turn off the monitor as described below.



To power down the DektakXT system:

- 1 Close the Vision64 software as described in [Closing Vision64 on page 5-1](#).
- 2 Press the black OFF button on the EMO Box (see [Figure 3-5](#)). This shuts off power to all system devices but the computer, monitor, power supply adapter, and 24 VDC control circuit in the EMO Box.
- 3 Select **Start > Shut Down** from the Windows 7 **Start** menu, and then click **Shut Down** in the dialog box that appears.
- 4 Turn off the monitor.

LOADING AND UNLOADING THE SAMPLE



WARNING

If the sample does not freely clear the stylus, click the Tower Up  to raise the stylus so that it is safely above the sample. Failure to do so can damage both the stylus and the sample.

Loading the Sample

Click the **Unload Sample** button  on the toolbar above the Live Video Display to move the scan stage forward 55mm (two inches). You can now conveniently place a sample on the sample fixture (see [Figure 3-6](#)) remove it without risk of damage to the stylus or the sample.

Click the **Load Sample** button  to move the scan stage backward its home position. Use the manual or auto stage controls to fine-position the area of interest on the sample beneath the stylus. For instructions, see [Using the Manual Stage-Positioning Controls on page 3-6](#) and [Using the Auto Stage-Positioning Controls on page 3-7](#).



Figure 3-6: Sample Loaded on the Theta Sample Fixture (Chuck)

Unloading the Sample

When a scan routine is complete, the stylus automatically lifts off the surface. To remove the sample, from the fixture, click the **Unload Sample** button  to make the system move the sample-positioning stage forward. You can now lift your sample off the fixture.

TOWERING UP AND DOWN

You must slowly lower the tower assembly to bring the feature that you want to measure into focus in the Live Video Display. To do this, click the **Tower Down**  button on the toolbar above the Live Video Display.

To raise the tower assembly, click the **Tower Up**  button.

To bring the tower all the way up to its home position, click the **Tower Home** button .

NOTE – The DektakXT profiler automatically towers down to bring the stylus into contact with the sample whenever you start a single-scan measurement, 3D map scan, or automation program.



WARNING

The tower assembly has a total travel range of 50mm, so sample heights must not exceed 50mm.

ADJUSTING THE ILLUMINATION

After lowering the tower to focus the camera on your sample, you must adjust the illumination level of the video image displayed on the monitor. To do this, move the slider on the Intensity Bar at the bottom of the right pane of the Live Video Display (see [Figure 3-7](#)). Move it to the right to increase the illumination and to the left to decrease it. The feature that you want to scan should be clearly illuminated.

NOTE – When you save a Vision recipe, the illumination level is automatically included along with the other measurement settings.

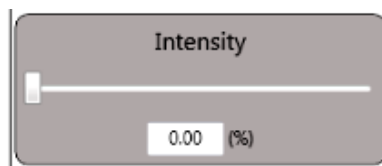


Figure 3-7: Intensity Bar

USING THE MANUAL STAGE-POSITIONING CONTROLS

If your DektakXT system includes the manual sample-positioning stage (see [Figure 3-8](#)), you must use the procedures described in this section to adjust both the X and Y positions.

Adjusting the X-Y Position

To position a sample using the manual sample-positioning stage controls:

- 1 Ensure the stylus is not touching the sample surface. If it is, click the **Tower Up** button  on the toolbar.
- 2 Position the scan start site by using the X-Y positioning levers.
 - Pull the lever below the front of the platform for coarse X movement.
 - Pull the lever below the left side of the platform for coarse Y movement.
 - Use the respective knobs to finely position the sample.

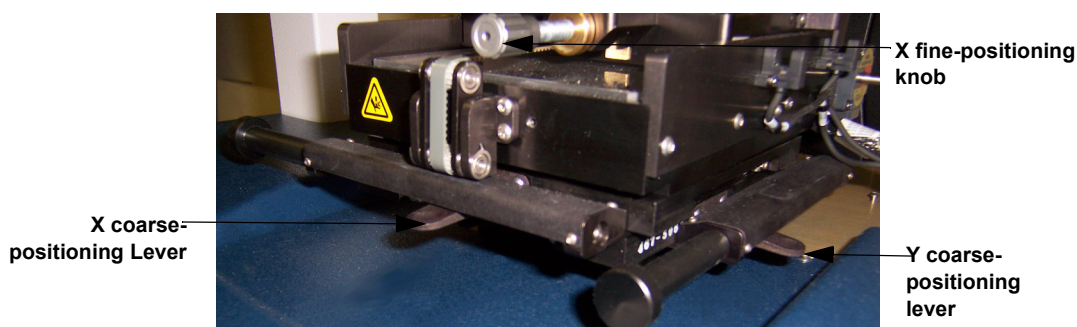


Figure 3-8: X-Y Positioning Levers on the Manual Sample-Positioning Stage

NOTE – After fine-tuning the scan site using the X and Y positioning levers, you may have to re-null the tower to adjust for skew. (To re-null the tower, tower up and then tower down.)

Leveling the Stage

All stage configurations of the DektakXT system allow you to manually level the sample-positioning stage by turning the leveling knob below it (see [Figure 3-9](#)). The closest possible manual leveling ensures the best profiler performance. Guidelines for leveling the stage appear after the picture.

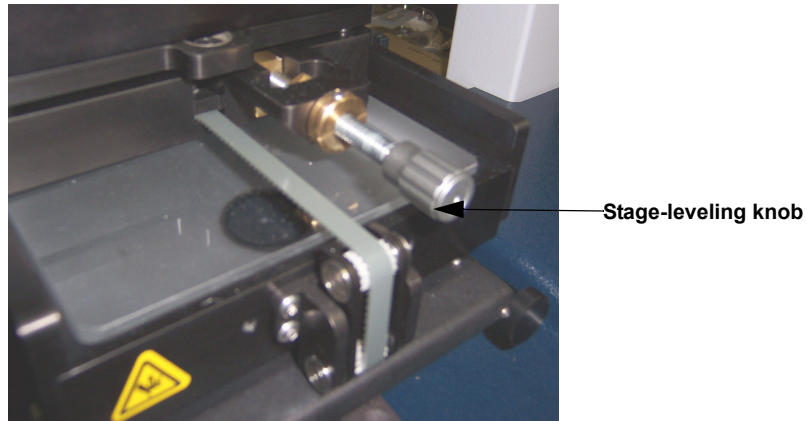


Figure 3-9: Stage-Leveling Knob

As you perform manual stage leveling, follow these guidelines:

- To view the effect of leveling on the profile trace in real time, perform stage leveling while a scan measurement is in progress.
- To verify that the maximum possible level has been obtained, position the cursors so that they intersect the same horizontal plane.
- If the profile trace is extremely off-level, change the measurement range to 5240kÅ. Level the trace, change to the intermediate range, and then repeat the procedure until the stage is leveled. The best level is achieved by using the 6.5kÅ range.

USING THE AUTO STAGE-POSITIONING CONTROLS

When you open Vision64, the Live Video Display appears by default. On its right-hand side, it contains two instrument control panels—the X/Y Control Panel and the Theta Control Panel.

X-Y Control Panel

Prior to a taking measurement, you must position the area of interest on the sample under the stylus by adjusting the X-Y position of the motorized sample-positioning stage. Instructions for doing this appear after the figure.

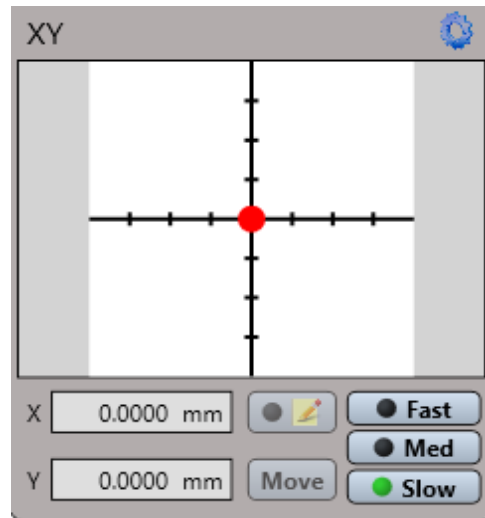


Figure 3-10: X-Y Stage Control Panel

To set the X-Y position of the motorized sample-positioning stage:

- 1 In the X-Y Control Panel in the Live Video Display (see [Figure 3-10](#)), click the blue Gear icon in the upper right corner to enter the select the units as well as the speeds for Fast, Medium, and Slow (see [Figure 3-11](#)). If you select the **Grab Circle to Move** check box, you must grab the red circle in the middle of the X-Y Control Panel before you can adjust the X/Y position of the motorized stage. When your settings are complete, click **OK**.

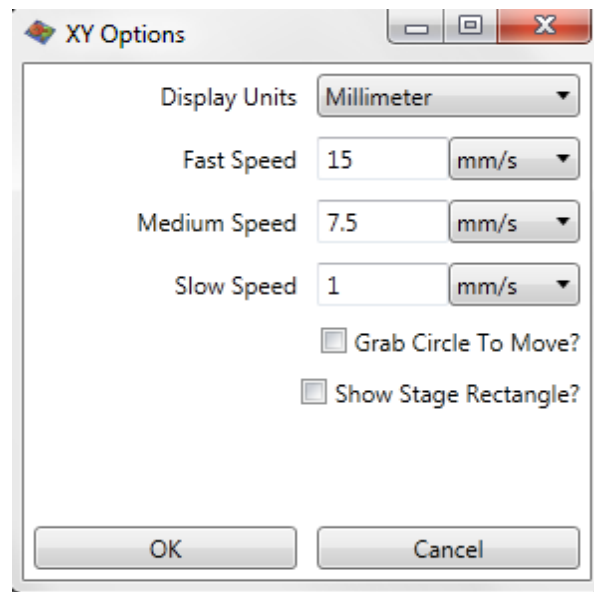


Figure 3-11: X/Y Options Dialog Box

- 2 In the lower right corner, click the speed at which you want the stage to travel.
- 3 Do one of the following:
 - Holding down the left mouse button, drag the red dot in the center of the cross hairs. The dot becomes an arrow that you can drag with the cursor. The real time X and Y positions of the stage appear in the boxes

- at the lower left. Click and drag to move the stage to another area of interest and display it in the Live Video Pane. When you have obtained the correct stage position, release the mouse button.
- Click the **Edit Mode** button . Either type your locations in the **X** and **Y** fields or click the **Move** button to move the stage to those locations.

Theta Control Panel

Prior to a taking measurement, you must place the area of interest on the sample under the stylus by adjusting the position of the motorized theta sample-positioning stage. Instructions for doing this appear after the figure.

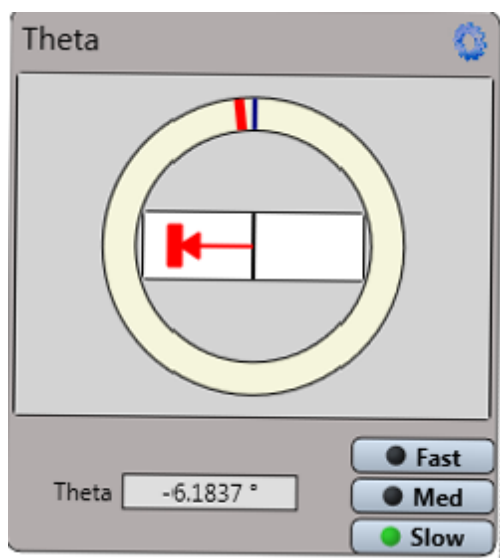


Figure 3-12: Theta Stage Control

To set the position of the motorized theta sample-positioning stage:

- 1 In the Theta Control Panel in the Live Video Display (see [Figure 3-12](#)), click the blue Gear icon in the upper right corner to enter the units as well as the speeds for Fast, Medium, and Slow on both the R Axis and the Theta Axis (see [Figure 3-13](#)). If you select the **Grab Rectangle to Move** check box, you must grab the red rectangle in the middle of the Theta Control Panel before you can adjust the theta position of the motorized stage. When your settings are complete, click **OK**.

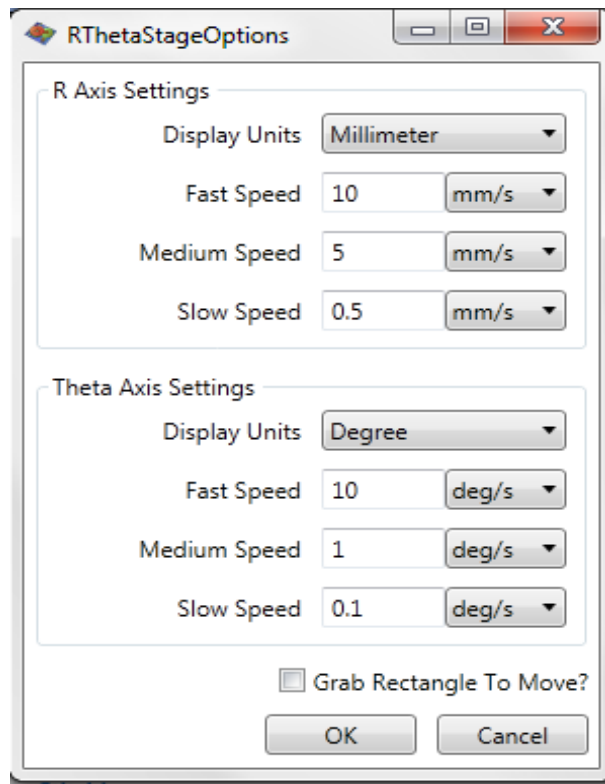


Figure 3-13: RTheta Stage Options Dialog Box

- 2 Holding down the left mouse button, drag the red bar in the center of the ring. The bar becomes an arrow that you can drag with the cursor. The real time theta position of the stage appears in the box below the ring. This position is graphically depicted by the moving red indicator on the yellow ring.
- 3 When you have obtained the correct stage position, release the mouse button.

REMOVING AN INSTALLED STYLUS

When a stylus becomes worn or you want to measure another type of sample, you must remove the currently installed stylus from the sensor head (see [Figure 3-18](#)) before replacing it with a different one.

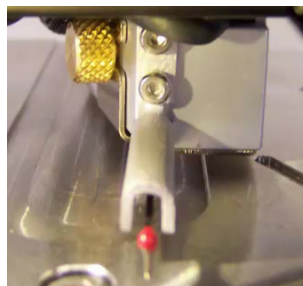


Figure 3-14: Sensor Head and Stylus on the DektakXT Profiler

To remove a stylus from the sensor head on the DektakXT profiler:

- 1 Locate the protective case in which the stylus was shipped and place it near the DektakXT stylus profiler (see [Figure 3-15](#)).



Figure 3-15: Protective Stylus Case

- 2 Locate the black plastic stylus exchange tool (see [Figure 3-18](#)) and place it near the stylus case.
- 3 Tower up to the Home position  to allow room for maneuvering.
- 4 On the profiler, turn the brass thumbscrew on the left side of the sensor head counter-clockwise to loosen the sensor head magnetic shield (see [Figure 3-16](#)).

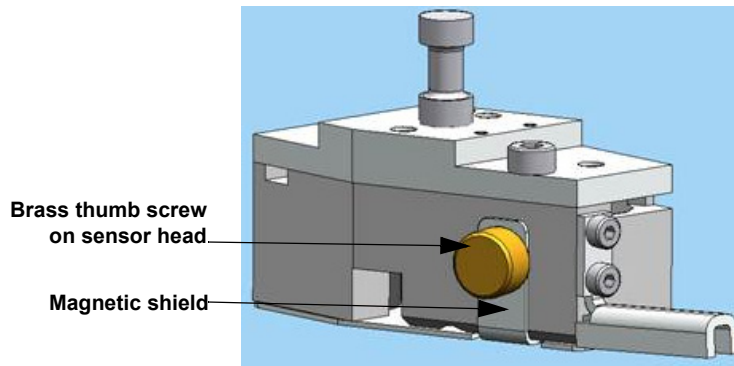


Figure 3-16: Sensor Head with Magnetic Shield Attached

- 5 Slip the shield off the pin on the right side of the sensor head.
- 6 Carefully move the shield toward the front of the profiler and pull it off the sensor head, making sure to avoid contact with the stylus.

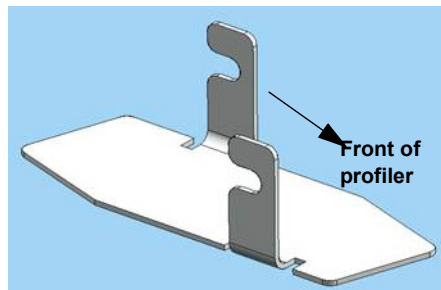


Figure 3-17: Magnetic Shield Removed from Sensor Head

- 7 Rotate the thumbscrew on the stylus exchange tool so that a gray circle (NOT a green one) is visible and the magnet is NOT engaged (see [Figure 3-18](#)).

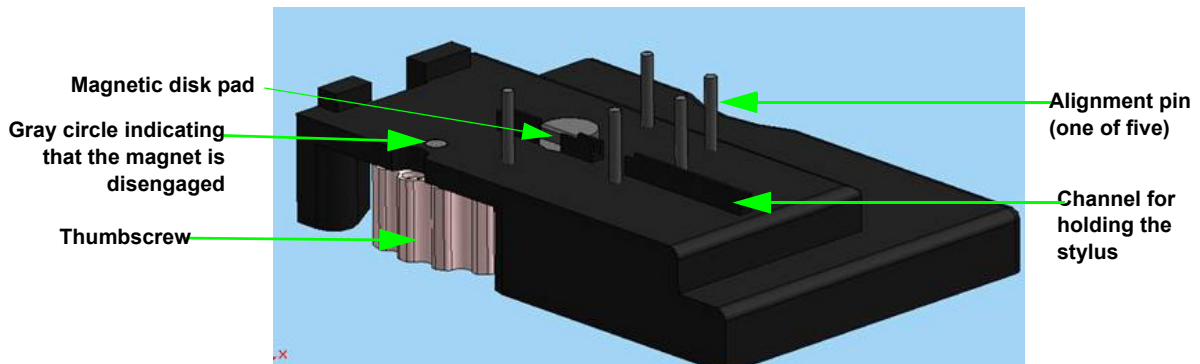


Figure 3-18: Stylus Exchange Tool with Its Magnet Disengaged

- 8 Position the stylus exchange tool beneath the sensor head (see [Figure 3-19](#)).
- 9 Holding the stylus exchange tool by its sides, align the alignment pins on its top with the outside of the front of the sensor head (see [Figure 3-19](#)). Gently push up until the tool is flush with the bottom of the sensor head. The ridge at the back of the stylus exchange tool must roughly line up with the back of the sensor head. The stylus tip should extend out through the front of the channel on the exchange tool.

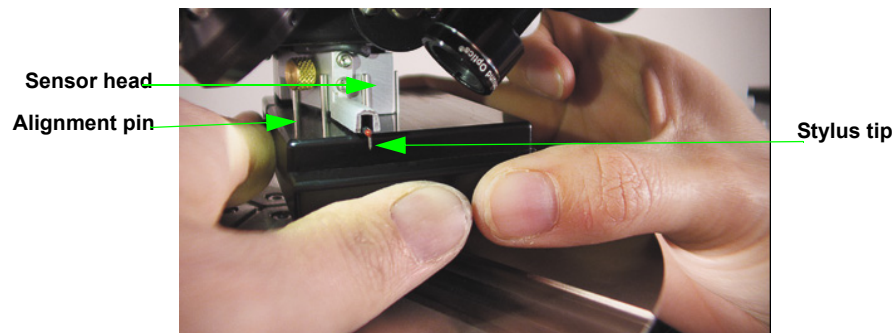


Figure 3-19: Stylus Exchange Tool Flush with the Bottom of the Sensor Head



WARNING

Avoid any personal contact with the stylus arm or tip. This can result in damage to the stylus.

- 10 Rotate the thumbscrew on the left side of the stylus exchange tool so that a green circle becomes visible and the magnet is engaged. The magnet now pulls the stylus into the channel on the exchange tool (see [Figure 3-18](#)). Lower the exchange tool containing the stylus from the bottom of the sensor head and take it to the protective case in which the stylus was shipped (see [Figure 3-15](#)).
- 11 To remove the stylus from the stylus exchange tool:
 - a. Disengage the magnet on the exchange tool by rotating the thumb wheel in either direction so that a gray circle replaces the green one.

- b. Using tweezers, gently grip the silver magnetic disk pad at the back of the stylus and then lift the stylus out of the channel on the stylus exchange tool.
- c. Place the stylus in its protective case with the tip pointing downward through the hole in the film in the lower part of the protective case (see [Figure 3-20](#)).



Figure 3-20: Inserting the Stylus Tip into the Hole in the Film in the Stylus Case



WARNING.

Always store the stylus in its protective case. Failure to do so can result in damage to the stylus.

INSTALLING A DIFFERENT STYLUS

NOTE – The following instructions assume that you have already removed the magnetic shield from the sensor head on the DektakXT profiler. If this is not the case, follow steps 4 - 6 in the previous section.

- 1 Tower up to the Home position  to allow room for maneuvering.
- 2 Locate the stylus exchange tool. If its green circle is visible, rotate the thumbscrew in either direction to disengage the magnet and replace the green circle with a gray one. (This means that the magnet is NOT engaged as shown in [Figure 3-21](#).)

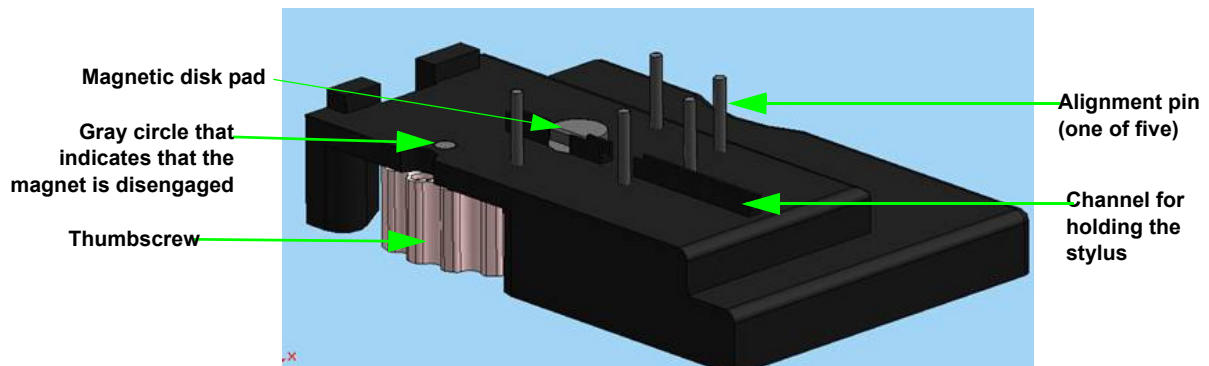


Figure 3-21: Stylus Exchange Tool with Its Magnet Disengaged

- 3 Locate the case that holds the stylus that you want to install. After opening the case, use tweezers to gently lift the stylus holding ONLY THE SILVER MAGNETIC DISK PAD AT ITS BACK END (see [Figure 3-22](#)).

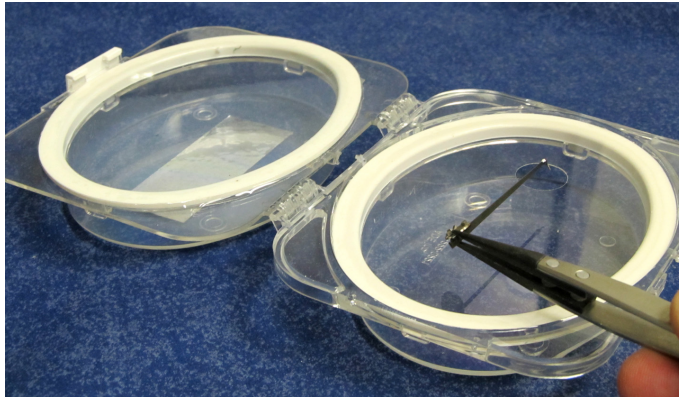


Figure 3-22: Lifting the Stylus from Its Case

- 4 Align the magnetic disk pad of the stylus with the magnetic disk pad on the stylus exchange tool (see [Figure 3-21](#)).
- 5 Seat the stylus in the channel on the exchange tool. The stylus arm should extend out through the front channel on the exchange tool (see [Figure 3-23](#)).

- 6 Rotate the thumb wheel on the left side of the stylus exchange tool counterclockwise to display the green circle and engage the magnet (see [Figure 3-23](#)).

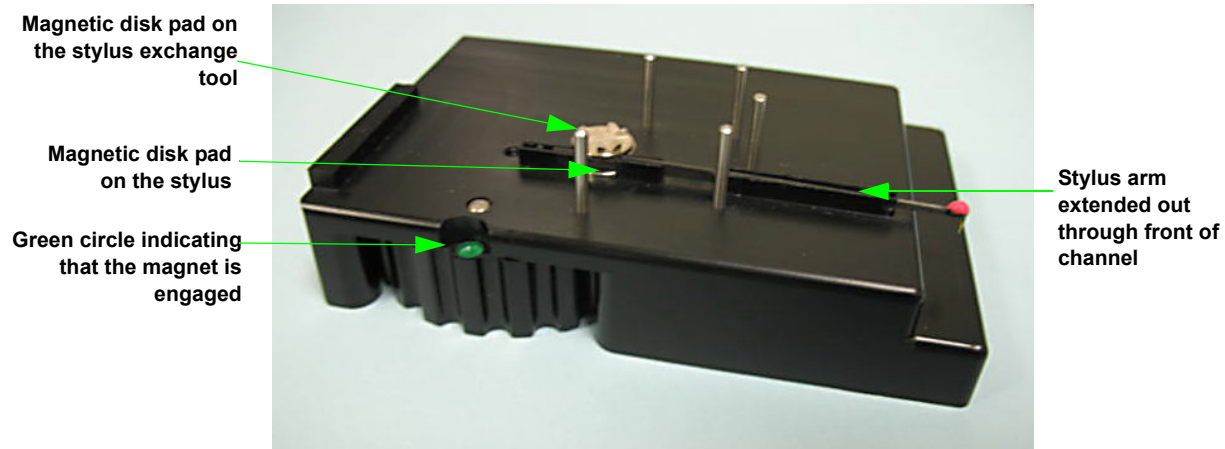


Figure 3-23: Stylus Exchange Tool with a Stylus Seated in the Channel and the Magnet Engaged

- 7 Place the stylus exchange tool underneath the sensor head on the DektakXT profiler. Holding the stylus exchange tool by the sides, align the alignment pins on its top with the outside of the front of the sensor head (see [Figure 3-19](#)). Gently push up until the tool is flush with the bottom of the sensor head. The ridge at the back of the stylus exchange tool must roughly line up with the back of the sensor head.

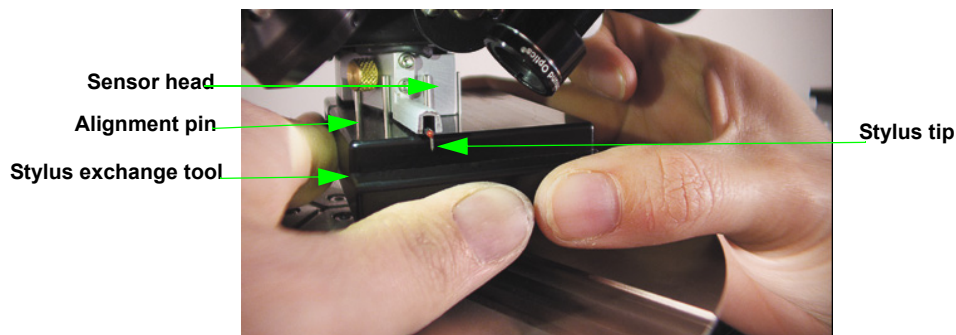


Figure 3-24: Stylus Exchange Tool Flush with the Bottom of the Sensor Head



WARNING

Avoid any personal contact with the stylus arm or tip. This can result in damage to the stylus.

- 8 Disengage the magnet by rotating the thumbwheel in either direction so that a gray circle replaces the green one.
- 9 Lower the stylus exchange tool.
- 10 Position the magnetic shield on the thumbscrew shaft on the left side of the sensor head.

- 11 Turn the brass thumb screw clockwise to attach the magnetic shield as shown in [Figure 3-25](#). Do not tighten the screw—just “snug” it.

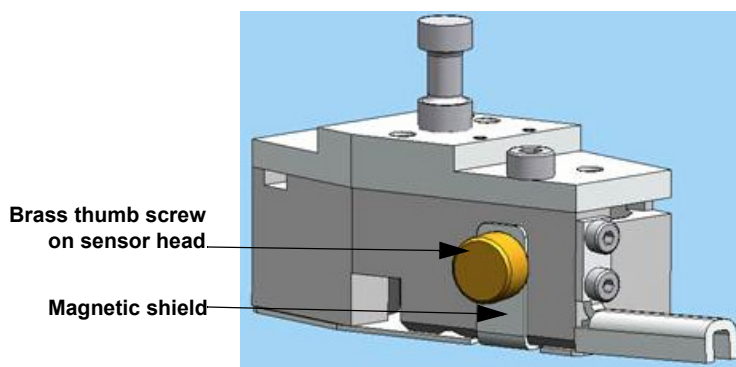


Figure 3-25: Sensor Head with Magnetic Shield Attached

CLEANING THE STYLUS TIP

- 1 Tower up to the Home position  t.
- 2 If there is a sample on the chuck or stage, remove it.
- 3 Clean the stylus tip using a lint-free synthetic cotton swab, which will not leave any fibers on the stylus. Moisten the swab with deionized water or laboratory-grade isopropyl alcohol. Lightly touch the stylus tip with the synthetic cotton swab to remove any dust. You may also use a small soft-bristle paintbrush. Do NOT use an air gun.



CAUTION

Dispose of wipes in an appropriately labeled solvent-contaminated waste container.

ELECTRONICALLY CONFIGURING AND CALIBRATING THE PROFILER

**WARNING**

Most of the settings available from the icons in the **Configuration** section of the Instrument toolbar should *NOT* be changed by the user without help from Bruker Customer Service. To reach Bruker Customer Service, call 800-873-9750.

To change the DektakXT hardware configuration settings:

- 1 On the **Instrument** tab of the Ribbon in Vision64, click one of the following icons to open its associated dialog box:

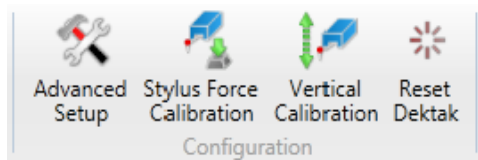


Figure 3-26: Configuration and Calibration Buttons on the Instrument Tab

- Click **Advanced Setup** to open a dialog box that allows you to make the settings for **Soft Touchdown** (which controls the gradual increase of the stylus force to a specified value) and **Tower LVDT Phase and Force** (which controls the production and processing of the electrical signals that correspond to surface variations of the sample). Call Bruker Customer Service for help in making your settings. When you are done, click **OK**.
- The **Stylus Force Calibration** wizard guides you through the process of calibrating the force with which the stylus tip contacts the sample.
- The **Vertical Calibration** wizard guides you through the procedure of taking a height or depth measurement and comparing the results with a calibration standard's certified value. An average measured value that is within $\pm 0.5\%$ of the certified value ensures that your DektakXT system is taking accurate measurements.
- The **Reset Dektak** function initializes the scan stage.

NOTE – For a full explanation of all DektakXT configuration settings, see the Vision64 online Help.

GENERAL CARE AND MAINTENANCE

Follow these guidelines:

- Do not use lubricants on the stage leadscrews.
- Always position the sample so that the stylus is the only part of the stylus assembly that touches the sample.

- Keep the environmental enclosure door closed both when the DektakXT system is in use and when it is not.
- Never connect or disconnect any cables when the power is on.
- Do not lower the tower without the stage assembly in place.
- Do not move a sample during a scan measurement.
- Avoid vibration and shock during measurements. For example, ensure that an operator does not bump a surface close to the profiler or the profiler itself during a measurement.
- Always raise the tower to the maximum vertical position when the system is not in use.



TAKING MEASUREMENTS AND ANALYZING DATA

This chapter tells you how to take manual and automated scan measurements. It also explains the manipulation and analysis of scan data.

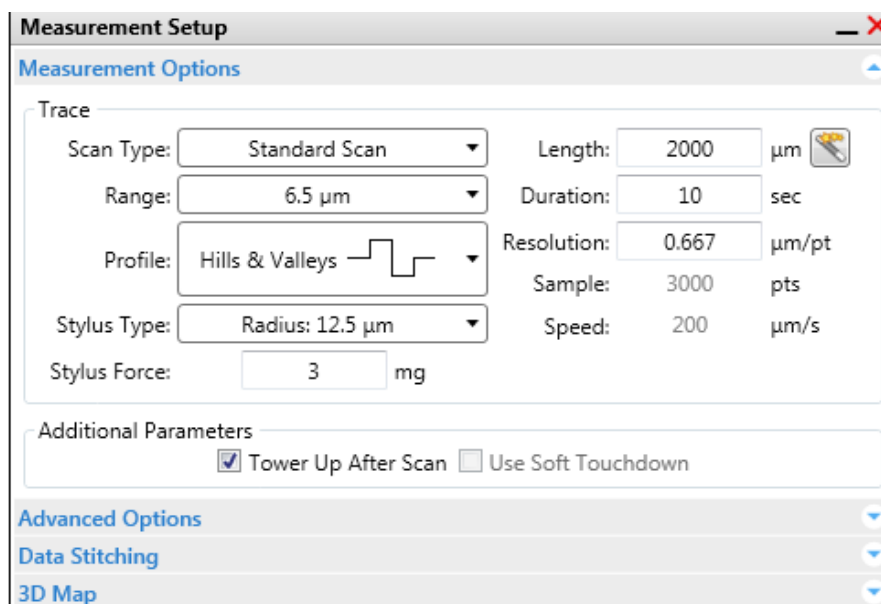


Figure 4-1: DektakXT System with an Open Enclosure Door

SETTING THE MEASUREMENT OPTIONS

Before taking a manual measurement or an automated series of measurements, you must make selections in the **Measurement Setup** window (see [Figure 4-2](#)). If you save these selections as a Vision recipe that you designate as the default, the system will automatically apply them to every future measurement. For instructions, see [Creating a Vision Recipe on page 4-18](#).

NOTE – If the **Measurement Options** window does not appear, click the **Measurement Setup** button  on the Ribbon.



The screenshot shows the 'Measurement Setup' window with the 'Measurement Options' tab selected. The 'Trace' section contains the following settings: Scan Type (Standard Scan), Length (2000 µm), Range (6.5 µm), Duration (10 sec), Profile (Hills & Valleys), Resolution (0.667 µm/pt), Sample (3000 pts), Stylus Type (Radius: 12.5 µm), Speed (200 µm/s), and Stylus Force (3 mg). The 'Additional Parameters' section has a checked box for 'Tower Up After Scan' and an unchecked box for 'Use Soft Touchdown'. The 'Advanced Options' section is expanded, showing 'Data Stitching' and '3D Map' options.

Figure 4-2: Measurement Options Tab of the Measurement Setup window

Settings on the Measurement Options Tab

Scan Type: Select from the following:

- **Standard Scan:** A normal scan type in which the scan is performed across the surface of a sample. Because the tower is nulled before each scan, each successive scan has its own reference point.
- **Static Tower Scan:** A special scan type in which the scan is performed across the surface of a sample, but the tower is nulled before only the first scan. Each successive scan therefore uses the same initial reference point.
- **Static Scan:** A special scan type in which the scan is performed at the same point. (The scan stage does not move.) The tower is nulled before the scan. This scan type is primarily used for determining the noise and drift of the system.
- **Map Scan:** If your system includes the 3D Mapping Option, select this scan type to measure, analyze, and view surface contour data in three dimensions (X, Y, and Z).

Range: Enter a value that indicates vertical resolution of the scan. When measuring extremely fine geometries, the 6.5 μm range provides a vertical bit resolution of 0.1 nm. For general applications, the 1.0 nm vertical resolution of the 65.5 μm range is usually adequate. When measuring thick films or very rough or curved samples, select the 524 μm range with 8.0 nm resolution.

NOTE – The selected scan range is scaled across the LVDT output of the stylus head sensor and digitized. The greater the selected scan range, the lower the vertical resolution of the measurement. The 6.5 μm range will provide a vertical bit resolution of approximately 0.1nm. The 65.5 μm range has a resolution of 1nm, the 524 μm range has a resolution of 8nm, and the 1mm range has a vertical resolution of 15nm. So while the 65.5 μm , 524 μm , and 1mm scan ranges would all work for a 10 μm step, the 65.5 μm is the best.

Profile: Select from the following:

- **Valleys:** Provides 90% of the measurement range below the zero horizontal grid line. This option is used primarily for measuring etch depths.
- **Hills and Valleys:** Provides 50% of the measurement range above the zero horizontal grid line and 50% below. This option is used in most applications, especially if the surface characteristics of the sample are not well known, or if the sample is out of level.
- **Hills:** Provides 90% of the measurement range above the horizontal grid line. This option is used primarily for measuring step heights.

NOTE – When setting up ranges and scan profile types, always think about keeping the stylus trace from “topping out” or “bottoming out” in the Data Acquisition window.

Stylus Type: Select the currently installed stylus type from the drop-down list.

Stylus Force: Enter a value between 1 mg and 15 mg.

Length: Enter a scan length between 50 μm and 55,000 μm (55 mm) for a non-stitched measurement.

Duration: Enter amount of time it will take to complete a given scan. Scan duration, in conjunction with scan length, determines the horizontal resolution of a scan. For most applications, a 10 - 20 second scan provides adequate resolution and throughput.

Resolution: Enter the horizontal resolution for the scan length and scan duration. The scan resolution is expressed in $\mu\text{m}/\text{sample}$, indicating the horizontal distance between data points.

Sample: Indicates the number of data points that the system should take on the sample during a measurement.

Speed: Indicates the scan speed in units of $\mu\text{m}/\text{s}$.

Tower Up After Scan: Select this check box to make the DektakXT stylus profiler automatically raise the tower to a safe position after each scan.

Use Soft Touchdown: If your system includes the 3D Mapping Option, select this check box to make the DektakXT stylus profiler increment the stylus force up to the specified value. This causes the stylus to descend more slowly, thus minimizing the possibility of scratching the sample.

NOTE – For instructions on making the settings on the **Advanced** Tab, see [Creating an Automation Recipe that Includes Deskew Points on page 4-10](#). For instructions on making the settings on the **Data Stitching** and **3D Map** tabs, see your Vision64 online Help.

TAKING A STANDARD MANUAL 2D MEASUREMENT

The most common measurement performed on the DektakXT system is a Standard manual 2D measurement, which consists of a single trace along the sample in the Y direction (that is, along the front-to-back axis). When the scan is complete, Vision64 provides an output of the two-dimensional trace, describing the height of surface features with an interactive Z versus Y plot.

The length of the trace that you can define depends upon the DektakXT stage that is installed. For a DektakXT system with the manual 150mm X-Y stage, the standard scan length can range from 50um minimum to 55mm maximum. For a DektakXT system equipped with an automated 150mm XY stage, the standard scan length can range from 50um minimum to 200mm maximum. Scan lengths from 55mm to 200mm use the DektakXT's data stitching capability, which is described in the online Help.

IMPORTANT! Always operate the DektakXT inside its acrylic environmental enclosure (see [Figure 4-1](#)). This enclosure protects the sample and scan area from adverse outside influences such as noise, vibrations, dust, and air currents. Always operate the system with the enclosure door closed.



WARNING

Always raise the tower prior to loading a sample. Failure to do so can damage the stylus and sample.

- 1 In the Vision64 **Measurement Setup** window, do one of the following:
 - If your system includes the X-Y or theta auto stage, click **Unload Sample**  in the Live Video Display. The tower moves to its full upward position, and the stage moves to its full front (unload) position.
 - If your system includes the manual X-Y stage, click **Tower Up**  in the Live Video Display and then use the manual stage controls to bring the stage to its full front position. For instructions, see Chapter 3.
- 2 Place the sample on the sample fixture (chuck). If you are measuring a wafer, this will be the vacuum wafer chuck. If you are measuring a solar sample, this will be the solar chuck. Otherwise, place the sample on the square base platform of the scan stage itself.
- 3 If your system includes a vacuum chuck, turn on the vacuum switch.
- 4 In the Live Video Display, click the **Load Sample** button . The scan stage moves back to its home position, ready for a measurement.

- 5 Click **Tower Down**  in the Live Video Display. The tower lowers to the measurement position with the stylus down, and the stylus makes brief contact with the sample. The stylus then moves to its Up position.
- 6 If necessary, adjust the Intensity slider in the Live Video Display so that the sample is clearly illuminated.

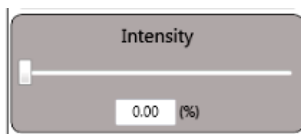


Figure 4-3: Illumination Bar

- 7 Adjust the position of the X-Y or theta stage until you find the location of interest on your sample.
- 8 Fine-position the location of interest in the center of the Live Video Display.

NOTE – Since the stylus scans across the sample in the Y direction, it is important to position the features of your location of interest so that they are perpendicular to the scan direction. For example, if you are measuring a step height standard, the step must run horizontally across the Live Video Display. Samples such as metals should be positioned so that the lay (the predominant direction of the surface texture) runs horizontally across the Live Video Display.

NOTE – Because the scan will move “Up” in the Live Video Display, the trace must be positioned above the stylus, thus ensuring that it will be fully measured.

- 9 On the **Measurement Options** tab of the **Measurement Setup** window, select **Standard Scan** (see [Figure 4-4](#)).
- 10 If you do not want to use the default Measurement Options settings that are stored in your Vision recipe, change any other settings on the **Measurement Options** tab of the **Measurement Setup** window. For definitions of the parameters in the **Measurement Options** window, see [Setting the Measurement Options on page 4-2](#).

NOTE – If your system includes the X-Y auto stage, click the **Teach** button  to the left of the **Length** field open a window that lets you drive the stage to the start-point of the scan.

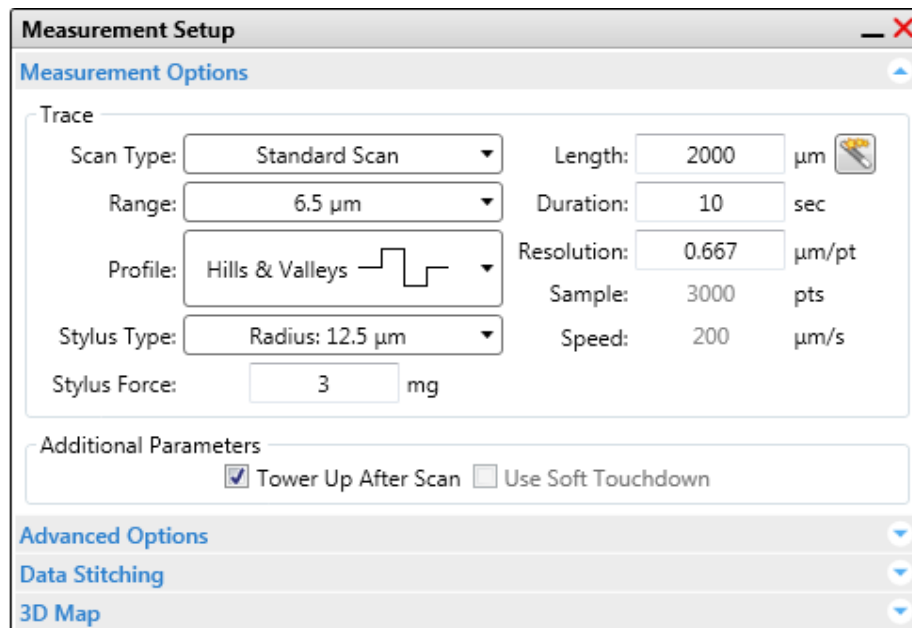


Figure 4-4: Measurement Options Window

- 11 Click the **Advanced Options** tab and make sure that the **Number of Measurements** is set to 1.
- 12 Click the **Measurement** button on the Ribbon (see [Figure 4-5](#)) and then select **Measurement**. The events that now occur are described in [What Happens During a Scan Measurement on page 4-6](#).

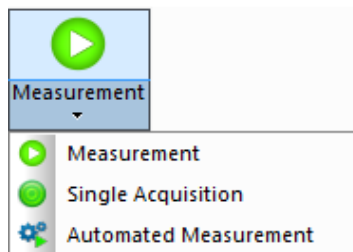
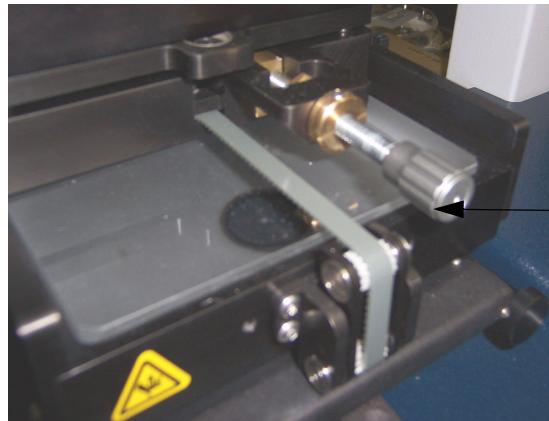


Figure 4-5: Measurement Buttons

- 13 Observe the measurement in real-time in the **Data Acquisition** window. If the scan hits or exceeds the top or bottom border of the **Data Acquisition** window, adjust the tilt on the scan stage (see [Figure 4-6](#)) and/or increase the **Scan Range** value in the **Measurement Options** window.



Stage-leveling knob

Figure 4-6: Stage-Leveling Knob

- 14 At the end of the measurement, the Data Analysis window appears (see Figure 4-6). If desired, click **Save > Dataset**.

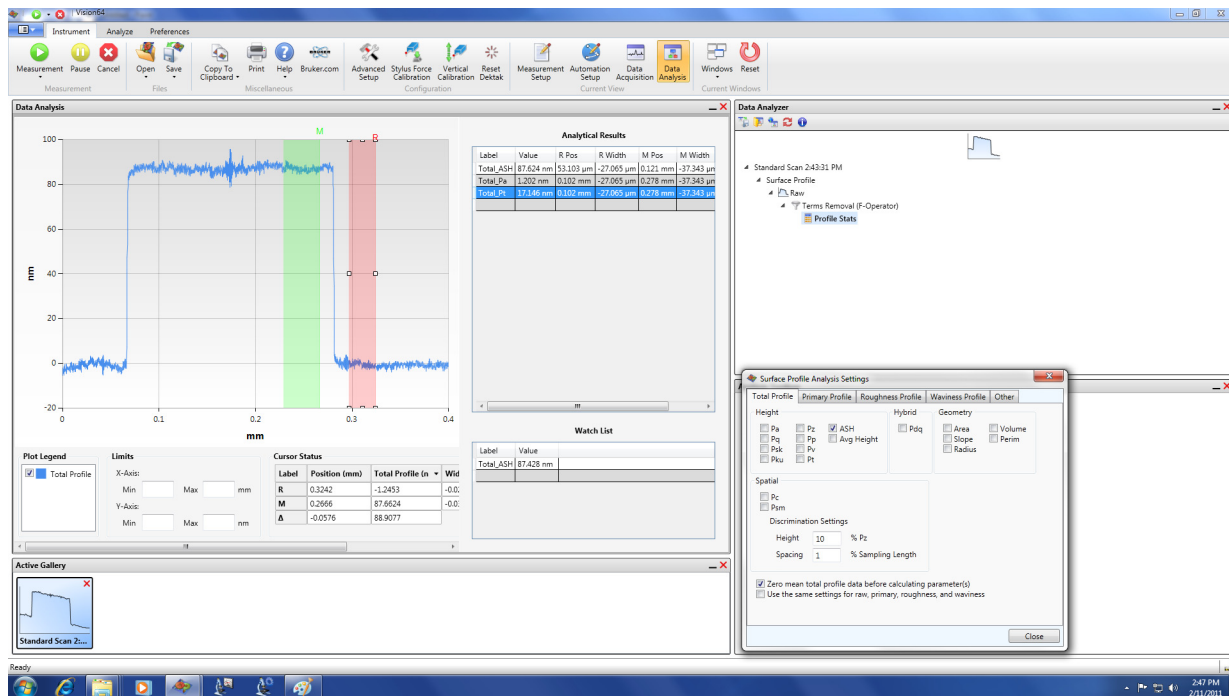


Figure 4-7: Data Analysis Window

What Happens During a Scan Measurement

When a measurement begins, the tower assembly lowers and the stylus descends. You can see the stylus and its shadow in the Live Video Display (see Figure 4-7).

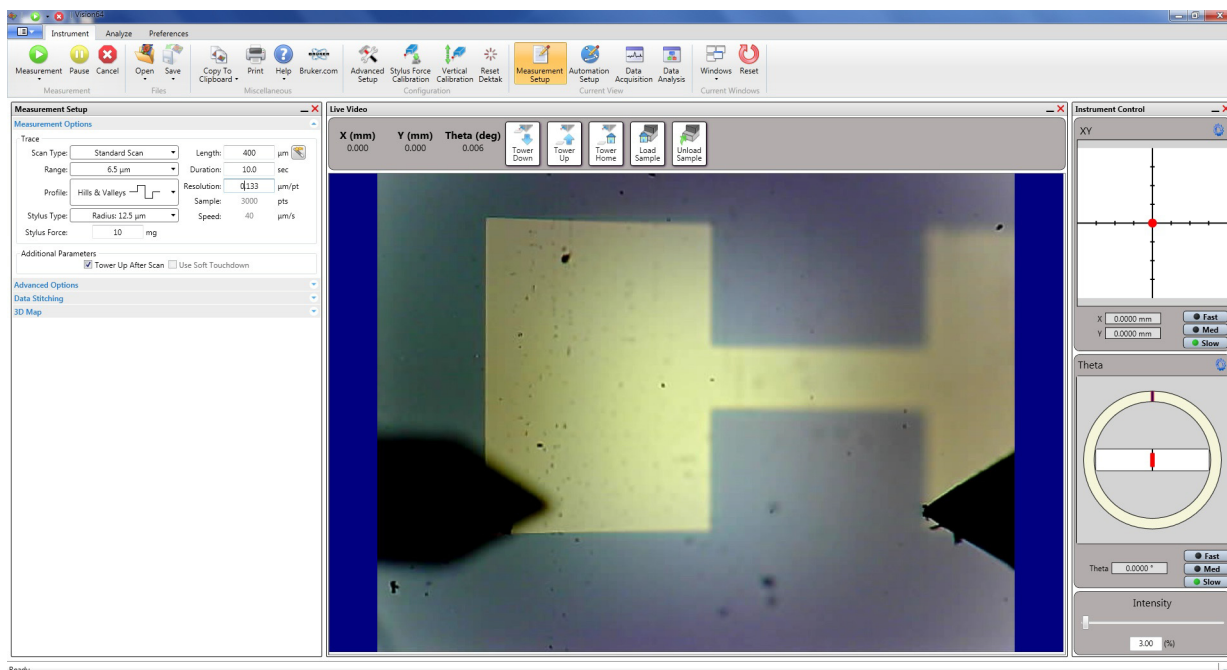


Figure 4-8: Live Video Display Showing the Descending Stylus and Its Shadow

After the stylus tip contacts the sample surface, it begins to scan over the surface features. The Live Video Display shows a real-time image of the stylus along with a measurement trace of the surface in the Data Acquisition window to the right (see [Figure 4-8](#)). It also provides the vertical and horizontal distances between the cursor/trace intercepts and the distances from the vertical and horizontal “zero” grid lines.

NOTE – If your system includes the 3-D Mapping package, or if the scan is set for Hill or Valley, the process described above is somewhat different. For example, during a measurement with the 3D Mapping package, a real-time picture of the sample appears during data collection (see [Figure 4-9](#)).

After the scan measurement is complete, the Data Analysis Display appears (see [Figure 4-10](#)). The surface features encountered by the stylus are represented as a two-dimensional profile. To the right, the output display shows a list of the scan parameters along with any user-requested analytical results. If you have created and activated a database, that database appears beside the Data Analysis display (see [Figure 4-25](#)).

At the end of the scan measurement, the tower and stylus automatically move back to their starting positions, and the system is immediately ready for the next measurement.

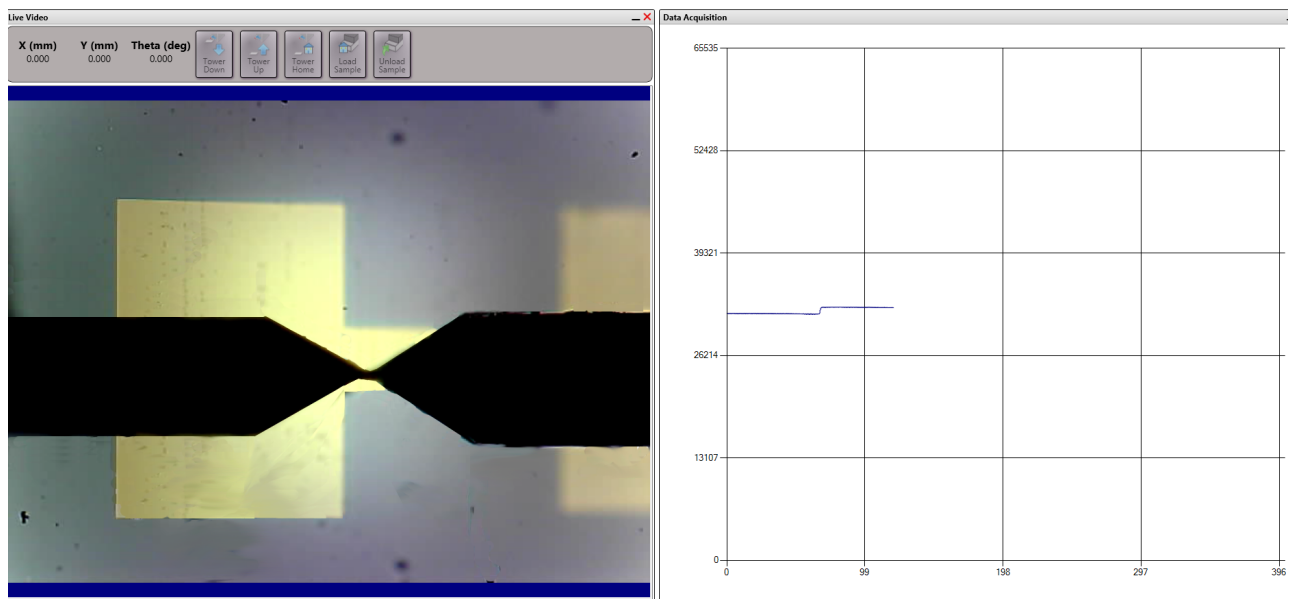


Figure 4-9: Live Video of the Stylus with the Real-Time Measurement Trace on the Right

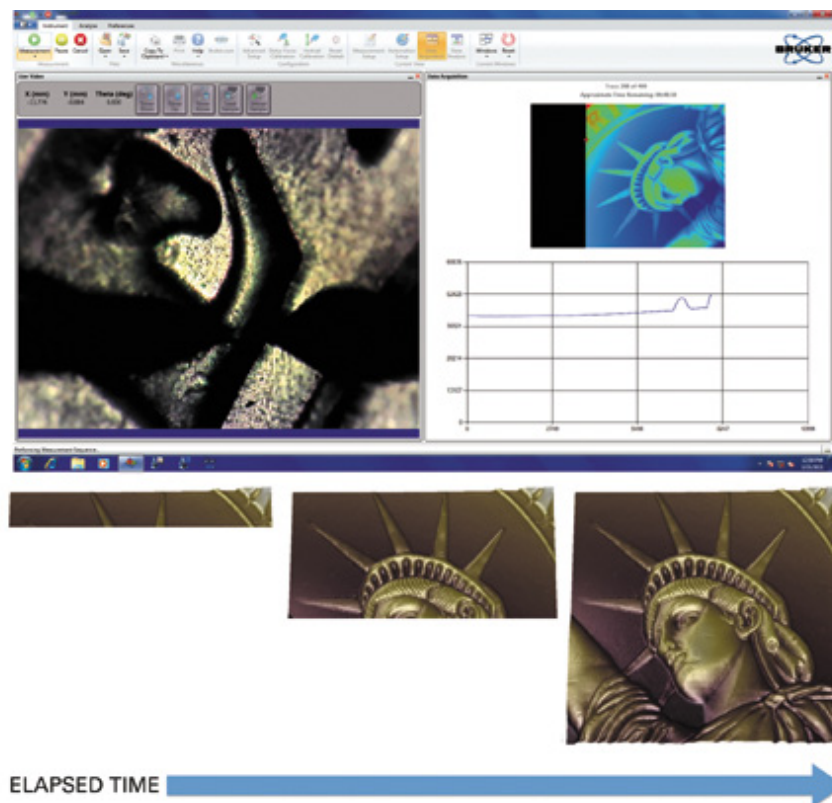


Figure 4-10: Real-Time Picture of the Sample During a Measurement Taken with the 3D Mapping Package

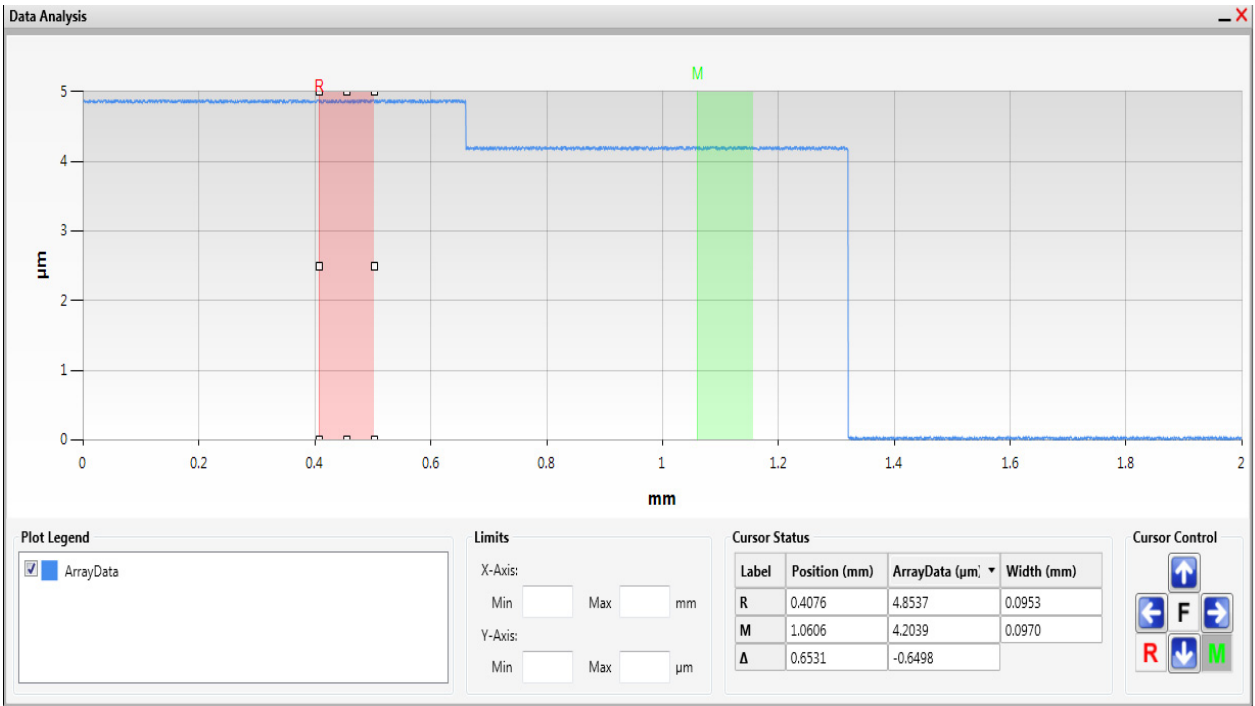


Figure 4-11: Data Analysis Display

CREATING AN AUTOMATION RECIPE THAT INCLUDES DESKEW POINTS

When you are developing an Automation recipe for a production reference sample, all programmed X and Y coordinates relate to the position of that particular sample as it rests on the stage. It is unlikely that you can load subsequent samples at the exact physical location of the reference point that was used to define the Automation recipe.

To compensate for such skewing, you can establish Deskew reference and measurement points on a reference sample at the time that the Automation recipe is defined. You may select any easily identifiable landmarks on the reference sample as Deskew points (for example, the test pads on a silicon wafer or substrate corners). When the system runs the Automation recipe, it refers to these Deskew points to correct for variations in the positions of your samples.

To create and run an Automation recipe that includes Deskew points:

- 1 Position your reference sample on the stage so that the area that you want to use as your Deskew reference point is visible in the Live Video Display. The Deskew reference point anchors the sample location to a fixed stage position.
- 2 Click the **Automation Setup** button  on the Ribbon. The Automation Editor appears.
- 3 Tower down .
- 4 To set the Deskew reference point:
 - a. In the Live Video Display, drive the stage to the area that you want to use as the Deskew reference point.
 - b. In the Automation Editor, click **Set Reference Point**. A red circle enclosing an R now appears in that location (see Figure 4-12).

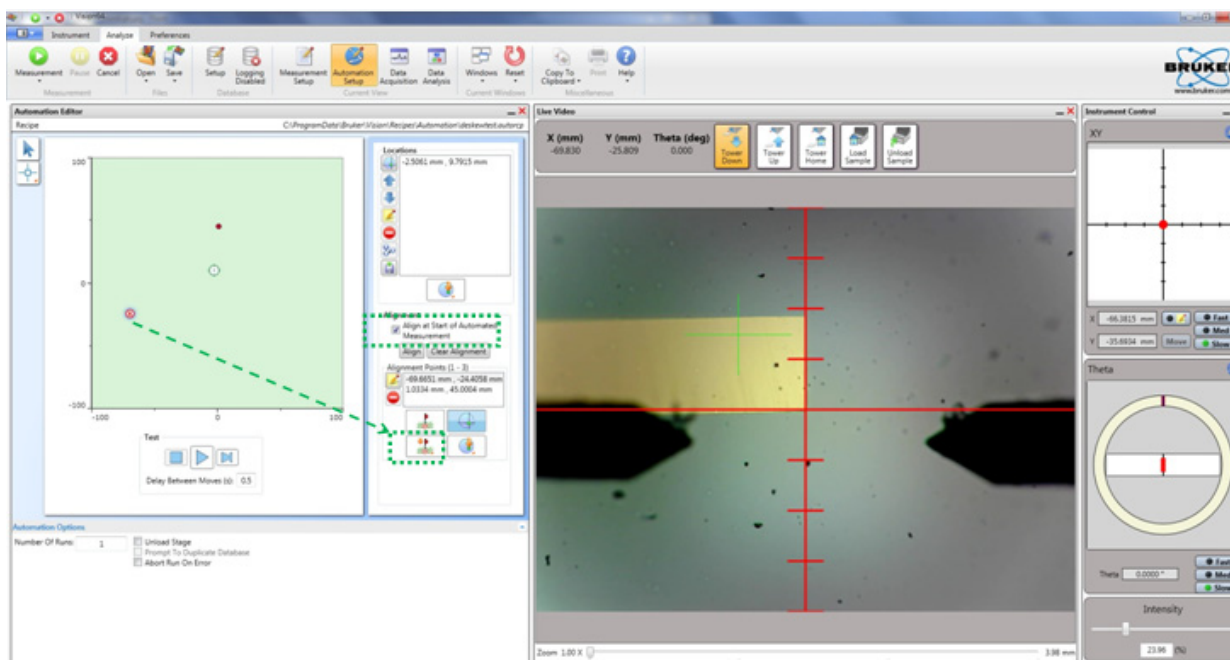


Figure 4-12: Setting the Deskew Reference Point

- 5 To set the Deskew alignment point:
 - a. Drive the stage to the area on the image that you want to use as the Deskew alignment point.
 - b. Tower down .
 - c. In the Automation Editor, click the **Add Alignment Site** button. A solid red circle now appears at that location (see Figure 4-13).

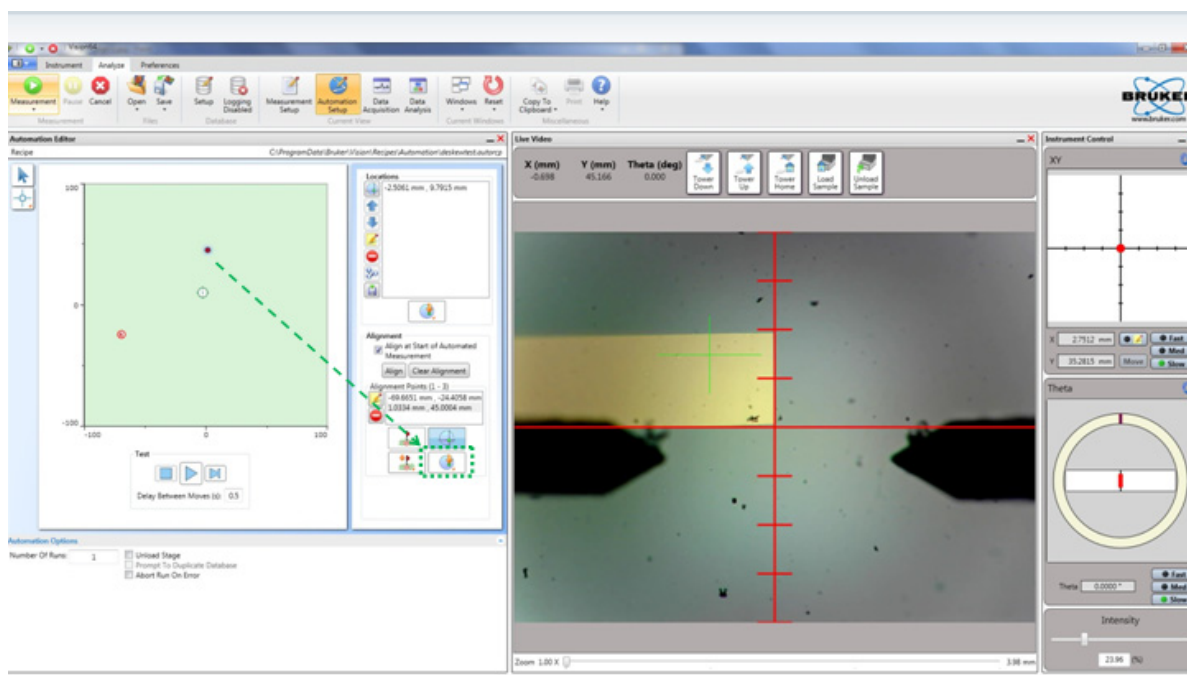


Figure 4-13: Setting the Deskew Alignment Point

- 6 To program the measurement points:
 - a. Drive the stage to the area on the image that you want to use as the first measurement point.
 - b. Tower down .
 - c. In the Automation Editor, click the **Measurement Site** button. A number outlined by a green circle now appears at that location (see Figure 4-14).
 - d. Repeat the above steps to define all further required measurement points.

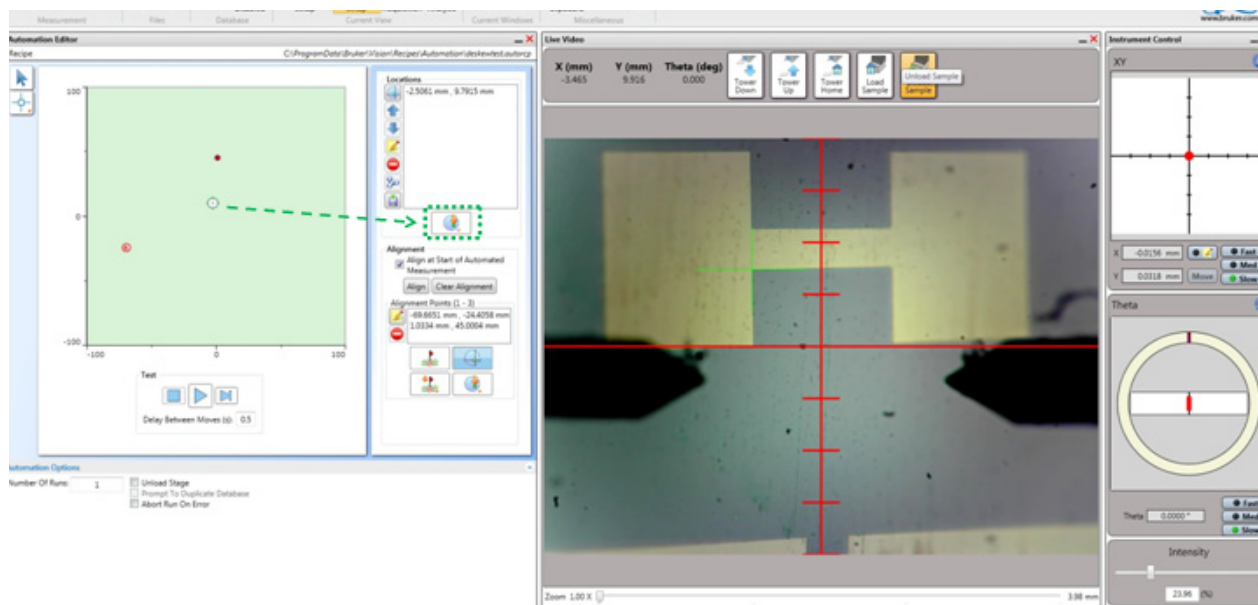


Figure 4-14: Setting a Deskw Measurement Point

- 7 In the Automation Editor, select the **Align at Start of Automated Run** check box to activate the Deskw feature. The system will now automatically run the Deskw recipe prior running this Automation recipe.
- 8 If desired, change the Automation Options at the bottom of the Automation Editor (see Figure 4-15).

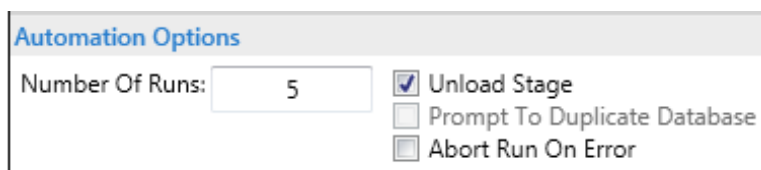


Figure 4-15: Options at the Bottom of the Automation Editor

- 9 Select **Save > Automation Recipe**. Name this recipe and then click **Open**.
- 10 Select **Measurement > Automated Measurement**. The system automatically runs the Deskw recipe followed by the Automation recipe.
- 11 As the measurement sequence initiates, an Automation Status message appears. Watch the live progress bar as the stage moves to the first location specified in the Automation recipe.
- 12 After the stylus arrives at each programmed point, you must use the Live Video Display and the Instrument Control Panel above it to tower down  and align that point. The stylus then runs over the sample, and the stage moves to the next location specified in the Automation recipe.

- 13 At any time, you can click to cancel the automated sequence.
- 14 At the end of an automation run, a message informs you that the system has “Completed script named [Script Name].” Click **OK**.

APPENDING ANALYTICAL FUNCTIONS

After you take a scan measurement, Vision64 can calculate a number of analytical functions for analysis of roughness, waviness, step height, and geometrical measurements. Frequently calculated functions include ASH (delta average step height), horizontal distance, and vertical distance. You can save your selection of analytical functions to a Vision recipe so that they are automatically calculated whenever you take a manual measurement or an automated series of measurements.

To select analytical functions:

- 1 On the Ribbon, click the Data Analysis icon .
- 2 With the live measurement results open, right-click on the **Analytical Results** pane in the Data Analysis window. The following pop-up menu appears.

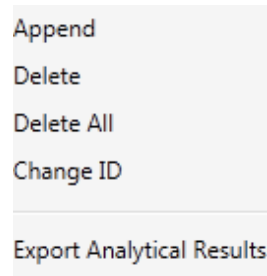


Figure 4-16: Analytical Results Pop-Up Menu

- 3 Select **Append**. The following window appears.

Total ProfilePrimary Profile

Height

☐ Pa
☐ Pz
☐ ASH

☐ Pq
☐ Pp
☐ Avg Height

☐ Psk
☐ Pv

☐ Pku
☐ Pt

Hybrid

☐ Pdq

Geometry

☐ Area
☐ Volume

☐ Slope
☐ Perim

☐ Radius

Spatial

☐ Pc
☐ Psm

Discrimination Settings

Height

10

% Pz

Spacing

1

% Sampling Length

☒ Zero mean data before calculating parameter(s)
☐ Use the same settings for raw, primary, roughness, and waviness

Cursor Positioning

Label	Position (mm)	Width (mm)
R	0.0000	0.0000
M	1.9993	0.0000
Δ	1.9993	

Calculate

Close

Figure 4-17: Analytical Functions window

- 4 Select your analytical functions and then enter the positions and bandwidths of the cursors that define the area in which the analytical functions should be calculated.
- 5 Click **Calculate**.

SETTING THE CURSOR LOCATIONS AND BANDWIDTHS

The red reference (**R**) cursor and green measurement (**M**) cursor in the Data Analysis Display define the portion of the profile trace on which to calculate analytical functions on the measurement results (see [Figure 4-18](#)). You can adjust the bandwidth at each cursor to average the data points within that cursor's bandwidth. This is especially useful for average step height measurements.

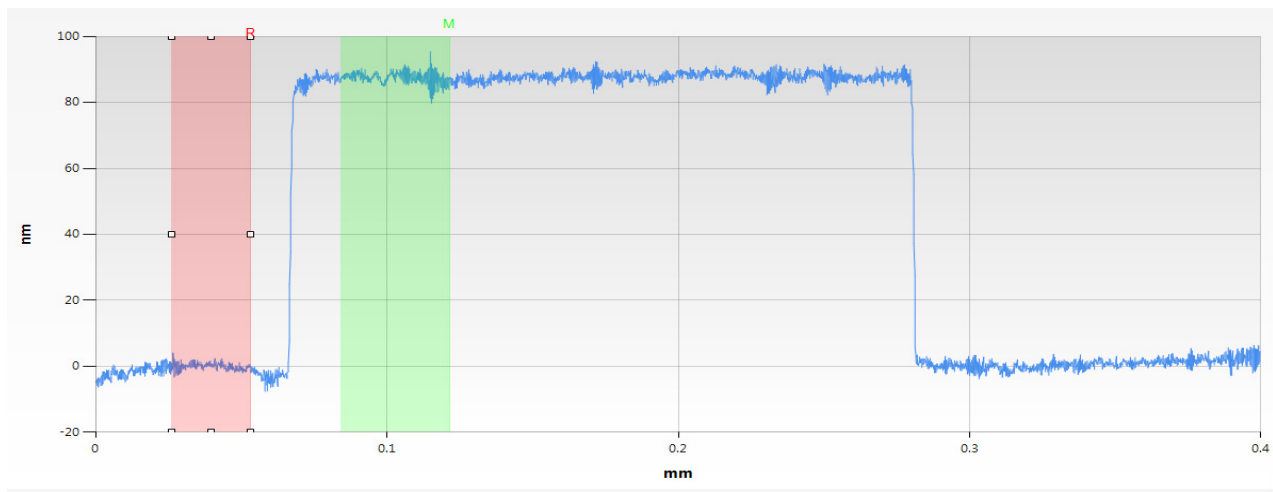


Figure 4-18: 2D Profile of the Data Analysis Display Showing the R and M Cursors

To change the position of each cursor on the measurement data, click on it and then drag it with the mouse.

To change the bandwidth of a cursor, click it to display small boxes that you can then drag. To reposition the cursors while maintaining the same distance between them, click on one of the cursors, and then hold down the Alt key while dragging that cursor. The second cursor moves along with it.

The locations of the **R Cursor** and **M Cursor** and their bandwidths appear in a box at the bottom of the Data Analysis window (see [Figure 4-7](#)). To change these settings, type in new values and press **Enter**.

NOTE – The numbers in the Cursor Status box indicate the points at which the cursors intercept the profile trace in relation to the horizontal scale.

Cursor Status			
Label	Position (mm)	Total Profile (μ ▾)	Width (mm)
R	0.5362	0.0223	0.0000
M	1.4182	0.0372	0.0000
Δ	0.8821	0.0149	

Figure 4-19: Cursor Status Box

APPLYING SOFTWARE LEVELING

Software leveling allows the system to quickly and automatically level the profile trace. You must software level the stage in order to obtain accurate step height measurements and accurate readings from analytical functions. Software leveling sets the reference and measurement cursors at zero to establish a reference for measurements.

To software level a trace from a live measurement in the Data Analysis window:

- 1 Click **Terms Removal (F-Operator)** in the Analysis Toolbox (see [Figure 4-20](#)) to add it to the Data Analyzer tree (see [Figure 4-21](#)).

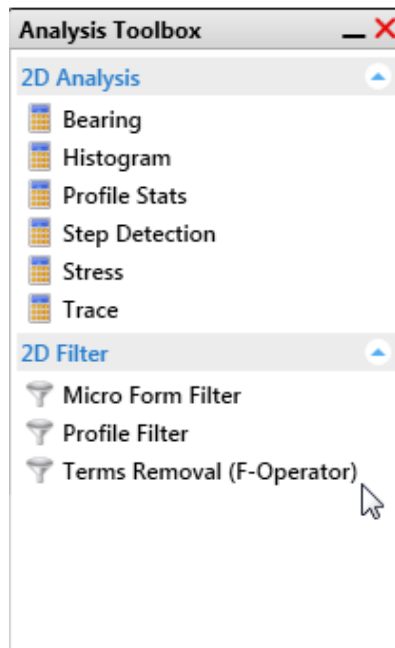


Figure 4-20: Terms Removal (F-Operator) in the Analysis Toolbox

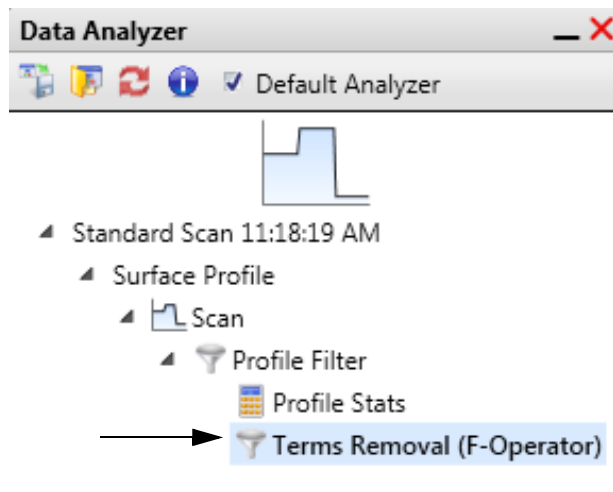


Figure 4-21: Terms Removal (F-Operator) in the Data Analyzer Tree

- 2 Position the R and M cursors as far apart as possible along the baseline of the step.
- 3 Right-click and select **Two-Point Linear Fit** from the **Data Leveling Settings** pop-up menu (see [Figure 4-22](#)).
- 4 The profile trace re-plots and levels with the R and M cursor intercepts at zero.

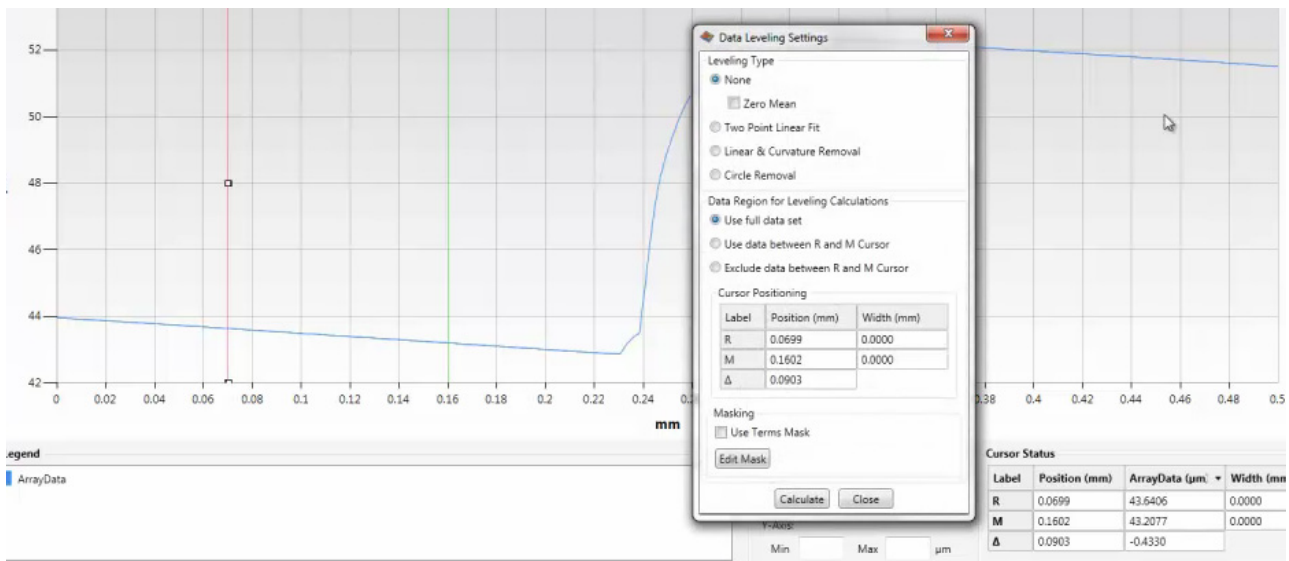


Figure 4-22: Data Leveling Pop-up Menu

CREATING A DATABASE

NOTE – Every time you change the selection of analytical functions that you want to log, you must create a new database.

To create a database:

- 1 Select the analytical functions, cursor positions, and analyses and filters that you want to include in this database.
- 2 Click the **Database Setup** button  and then click **Create New File** . A **Save** window appears. Enter a name for your database and then click **Save**.
- 3 As shown in [Figure 4-23](#), the **Database Setup View** window appears. The currently selected analysis flow is available from nested expandable lists in the upper right corner. A table to the left shows the parameters in the currently active database, whose path appears above the table.

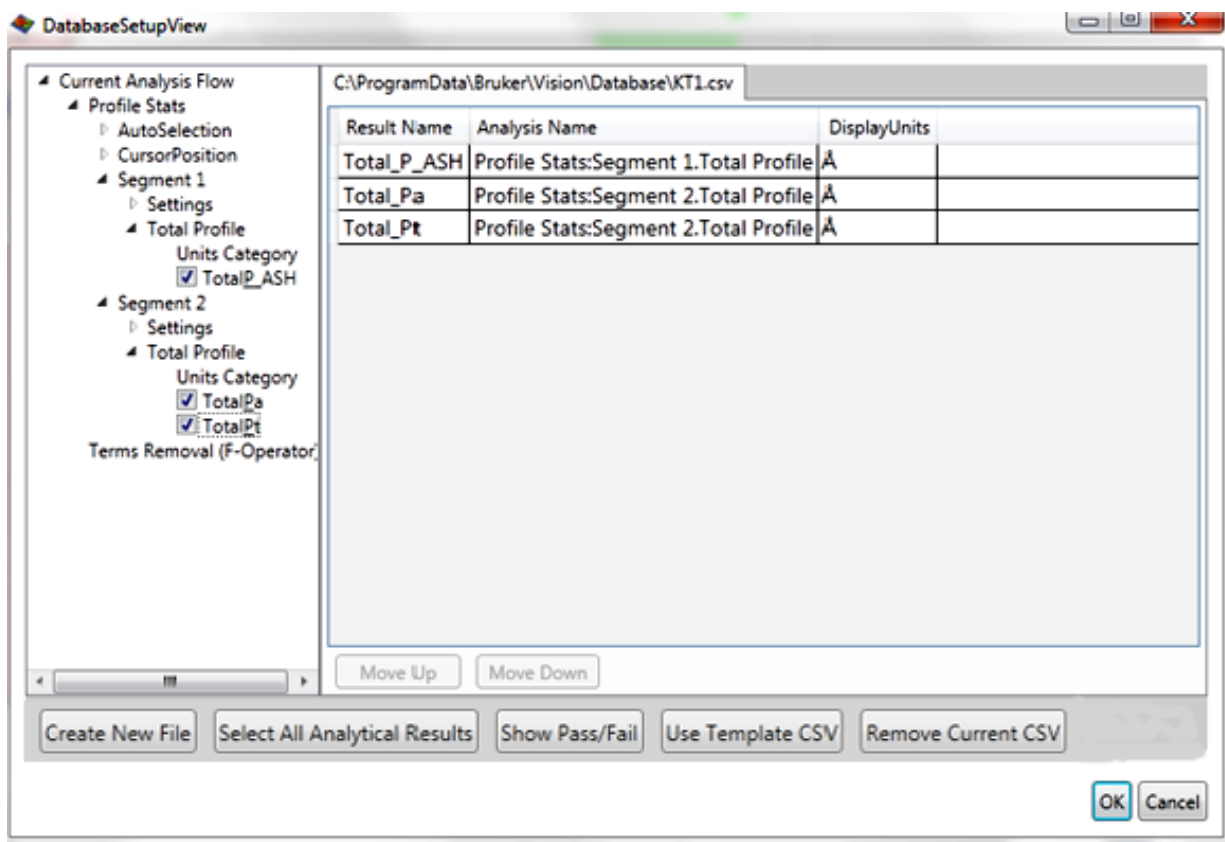


Figure 4-23: Database Setup View window

- 4 The following buttons appear at the bottom of the **Database Setup View** window:

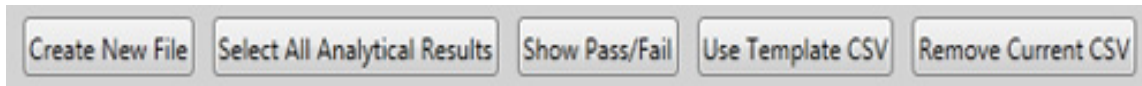


Figure 4-24: Buttons at the Bottom of the Database Setup View window

- 5 Click the desired button and make the appropriate entries.

NOTE – Click **Select All Analytical Results** to populate the database with the current selections or analysis parameters in the Analytical Results table.

- 6 Click **OK** in the **Database Setup** window.

- 7 Do one of the following:

- Toggle to **Database** button on the **Analyze** Tab to **Logging Enabled** .
- Click the **General Preferences** button  on the **Preferences**, set **Enable Data Logging** to **True**, and then click **OK**. A database file is now generated for each scan measurement (see Figure 4-25).

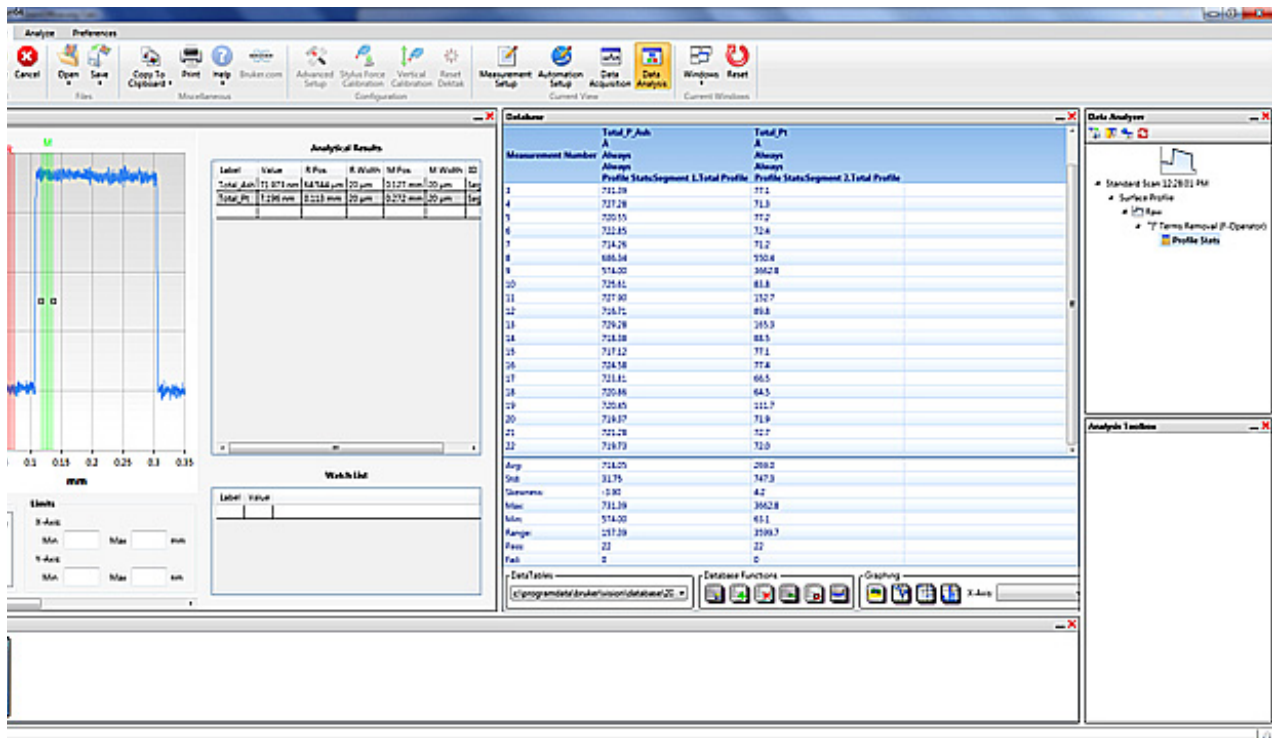


Figure 4-25: Data Analysis Display with an Open Database Window

CREATING AN ANALYZER RECIPE

An Analyzer recipe contains your selected analytical functions, 2D analyses, and filters. If your system includes the 3D mapping package, it also contains the default plot and 3D analysis/filter flow.

IMPORTANT! The Analyzer recipe that is open when you save a Vision recipe becomes part of that Vision recipe. This means that the analyses and filters that it contains will automatically be applied to every future dataset. For more information, see [Creating a Vision Recipe on page 4-22](#).

To create an Analyzer recipe:

- 1 Take a new scan measurement.
- 2 Select your analytical functions and cursor bandwidth settings as explained in [Appending Analytical Functions on page 4-13](#) and [Setting the Cursor Locations and Bandwidths on page 4-14](#).
- 3 Select your analyses and filters in the Analysis Toolbox as explained in the next section.
- 4 Click the **Open Database** button  at the bottom of the Database window and then open the database that you want to associate with this Analyzer Recipe.
- 5 On any Ribbon tab, select **Save > Analyzer Recipe**.
- 6 To make this Analyzer recipe a part of the currently open Vision recipe, select the **Default Analyzer** checkbox on the toolbar on top of the Data Analyzer.

Using the Data Analyzer and Analysis Toolbox

An Analyzer recipe is associated with each dataset and appears in the Data Analyzer (see [Figure 4-26](#)) whenever that dataset is active. An Analyzer recipe consists of the name of the active dataset, the dataset type (for example, Surface Height), the Raw Data analysis, and any other analyses and filters that have been selected in the Analysis Toolbox (see [Figure 4-27](#)).

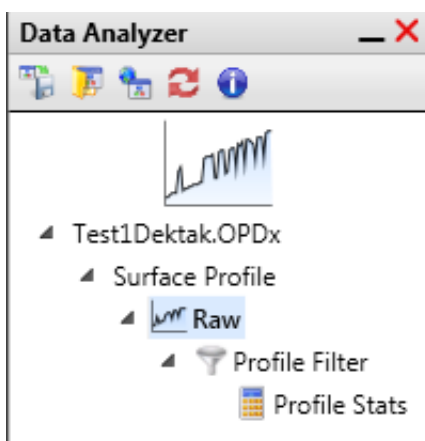


Figure 4-26: Data Analyzer

Below the Data Analyzer, the Analysis Toolbox contains all of the analyses and filters that can be applied to a dataset (see [Figure 4-27](#)).

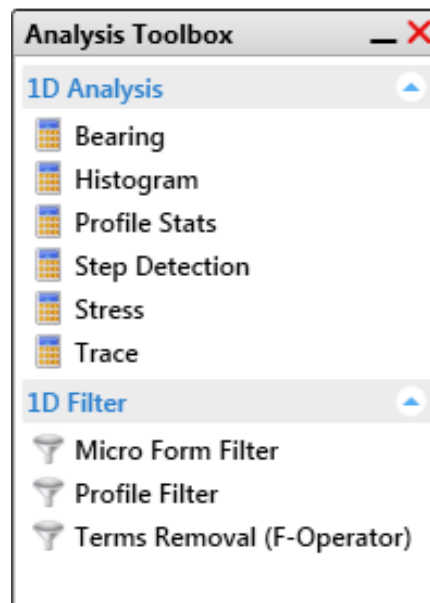


Figure 4-27: Analysis Toolbox

To apply an analysis or filter, click it in the Analysis Toolbox. The selected operation is immediately performed on the active scan dataset. In the Data Analyzer above the Analysis Toolbox, the operation now appears as part of the workflow tree (Analyzer recipe), as shown in [Figure 4-28](#).

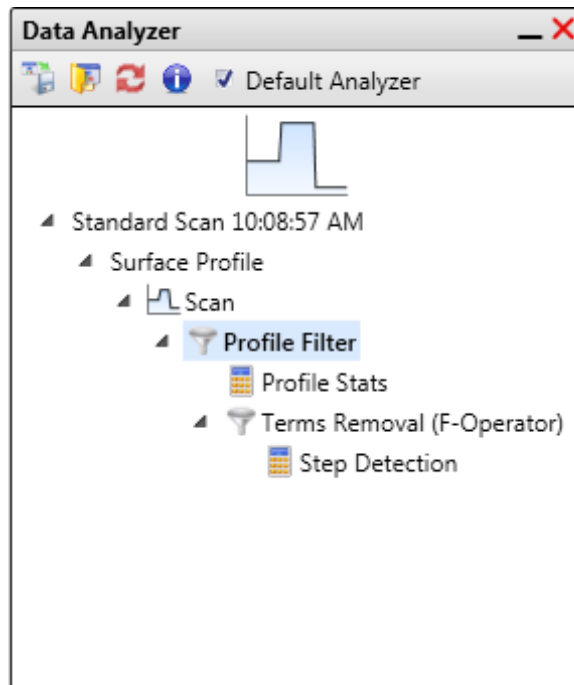


Figure 4-28: Workflow Tree that Includes Terms Removal (F-Operator) and Step Detection

IMPORTANT! After you click a second analysis (not a filter), the Analysis toolbox goes blank because you can perform only one analysis per branch. If you want to perform more than one analysis, click the **Profile Filter** branch and then add another analysis, which then becomes an additional branch of the Data Analyzer.

Setting the Parameters for an Analysis or Filter

To set the default parameters for an analysis or filter, right-click its icon, click **Default Settings**, make your settings in the window that appears, and then click **OK**. The settings will now be applied during every future operation of this type.

Selecting the Meta Data

To select the types of meta data to be stored with each dataset, click the **Meta Data** button  in the Data Analyzer.

To view the meta data that is already associated with an active dataset, click the **Meta Data** button on the toolbar above the Data Analyzer.

CREATING A VISION RECIPE

A Vision recipe contains all of the information that the system needs to make a single scan measurement. It also includes the Analyzer recipe that is active when you create and save the Vision recipe, so you can scan a sample and then visualize and analyze the resulting dataset with a single click.

To create and save a Vision recipe:

- 1 Select a scan type and make measurement selections in the **Measurement Setup** window.
- 2 Do one of the following:
 - To save this Vision recipe independently of the currently active Analyzer recipe, click **Save > Vision Recipe** on any Ribbon Tab.
 - To save the currently active Analyzer recipe as part of this Vision recipe, select the **Default Analyzer** check box on the Data Analyzer Toolbar and then click **Save > Vision Recipe** on any Ribbon Tab.
- 3 In the **Save As** window, enter a recipe name. The system supplies the file extension.
- 4 To save your settings as the default Vision recipe that the system will apply to every new scan measurement, select the **Set as the Startup Recipe** check box on top of the Data Analyzer.
- 5 Click **Save**.

VIEWING AND ANALYZING STORED DATA

DektakXT measurement results are stored in files with an .opdx extension. To open one, select **Open > Dataset**.

Multiple stored datasets can be simultaneously opened and displayed in the Active Data Gallery (see [Figure 4-28](#)). Click a thumbnail image of a dataset to make it the active one in the Data Analysis window (standard DektakXT) or the Main Display Area (3D Mapping Option).

To apply filters and analyses to the active dataset, make selections in the Analysis Toolbox. For instructions, see [Using the Data Analyzer and Analysis Toolbox on page 4-18](#).

To save any changes to the active dataset, select **Save > Dataset**.

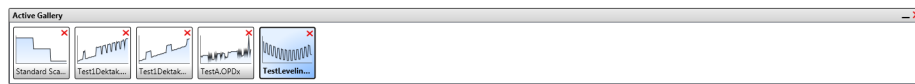


Figure 4-29: Active Data Gallery Containing Multiple Stored Datasets



USING VISION64

This chapter explains basic Vision64 operations and describes the user interface. For full instructions on using Vision64, see its online Help.

NOTE – For instructions on Vision64 software features that control the DektakXT profiler, see Chapter 3.

OPENING VISION64

Select **Start»Vision64** or double-click the Vision64 application button  on the desktop or task bar. The Vision64 Welcome screen appears, followed by the Vision64 Instrument tab, which includes the DektakXT Live Video Display.

Vision64 requires a software key to run (see [Figure 5-1](#)). If the key is not installed in a USB port, an error message appears. If this occurs, install the key and restart Vision64.



Figure 5-1: Software Key in a USB Port

CLOSING VISION64

Click the **Exit** button  in the upper right-hand corner. When you are prompted to confirm that you want to exit the program, click **Yes**.

Alternatively, you can close Vision64 by clicking the Vision64 application button  on the taskbar followed by **Close Window**.

IMPORTANT VISION64 DIRECTORIES

The Vision64 application directory, C:\Program Files\Veeco\Vision64, holds the Vision64 executable code. The directory C:\ProgramData\Veeco\Vision64 holds data and configuration information for the Vision64 application.

USING THE VISION64 ONLINE HELP

IMPORTANT! Online assistance in using Vision64 is immediately available through the Vision **Help** menu. This extensive Help system should always be your main source of information about using the Vision64.

Finding a Help Topic

To display Help in the Vision64 software, select **Help > Help Contents** (see [Figure 5-2](#)) or press the F1 key to open the Help Tab.

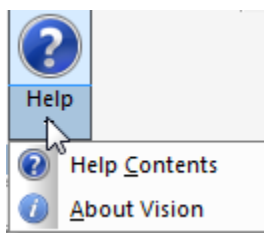


Figure 5-2: Help Button on the Vision64 Ribbon Tab

You can click into another Display Tab to change the contents of the Main Display Area and then return to the same Help topic by re-selecting the Help Tab.

The Help opens to a Table of Contents (on the left) and an introduction to Vision64. Help topics can be selected by clicking one of the following buttons in the left panel of the Help Tab:

- **Contents** lets you browse the Table of Contents. Double-click on a “book” (major heading) to view its “pages” (individual topics). Double-click on a page to view the topic.
- **Index** lets you view search terms that can help you locate topics. Type in the first few letters of the word or phrase that you are looking for. The scrolling list displays that portion of the alphabetical display. Double-click on a topic in the list to display it.
- **Search** lets you search for any word in the Help system. Type the word you want to find in the field provided. Then double-click on a found topic to view its information.
- **Favorites** displays the topics that you have previously added to a list.

At the top of the Help Tab, **Print**, **Back**, **Forward**, **Home**, **Refresh**, **Stop**, and **Add to Favorites** buttons allow you to navigate the system.

SELECTING WINDOWS FOR DISPLAY

Click the Windows button on the toolbar. From the list, select the windows that you want to display (see [Figure 5-3](#)).

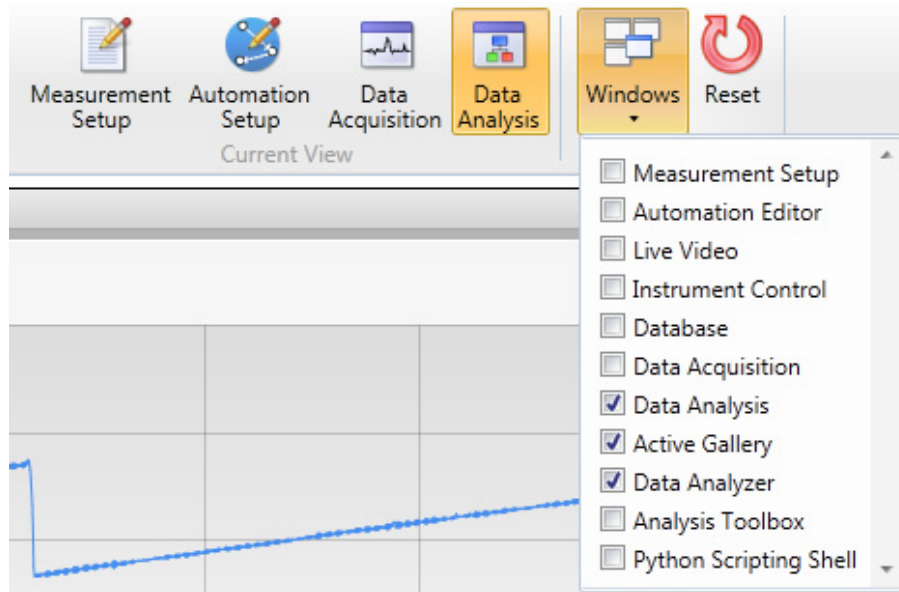


Figure 5-3: Vision64 Window Selection Buttons and Menu

WORKING WITH VISION VIEWS

The Vision64 workspace can simultaneously display one or more of the following Vision View windows, which appear in [Figure 5-3](#) through [Figure 5-7](#):

- Measurement Setup
- Automation Setup
- Data Acquisition
- Data Analysis (which includes the Data Analyzer and Analysis Toolbox if Raw Data is selected)

You can change the size and layout of each Vision View by clicking and dragging with the mouse. You can save each configuration by clicking **Save > Vision Views**. If you save your preferred set of Vision Views as the startup, it will appear each time that you start Vision64.

Click the **Reset** button to return to the factory-set configuration of the currently displayed Vision View. Click **Reset All** to return to all of the factory-set configurations of all four of the Vision Views



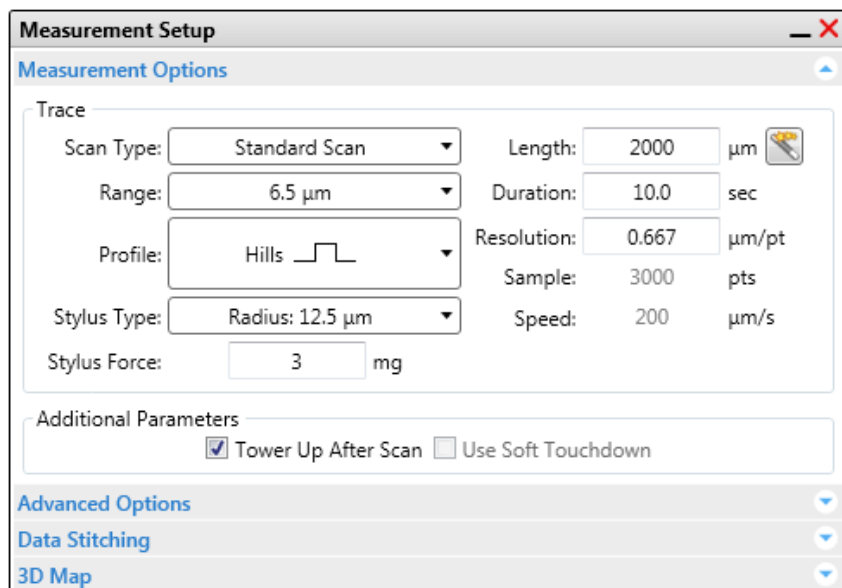


Figure 5-4: Measurement Setup Vision View

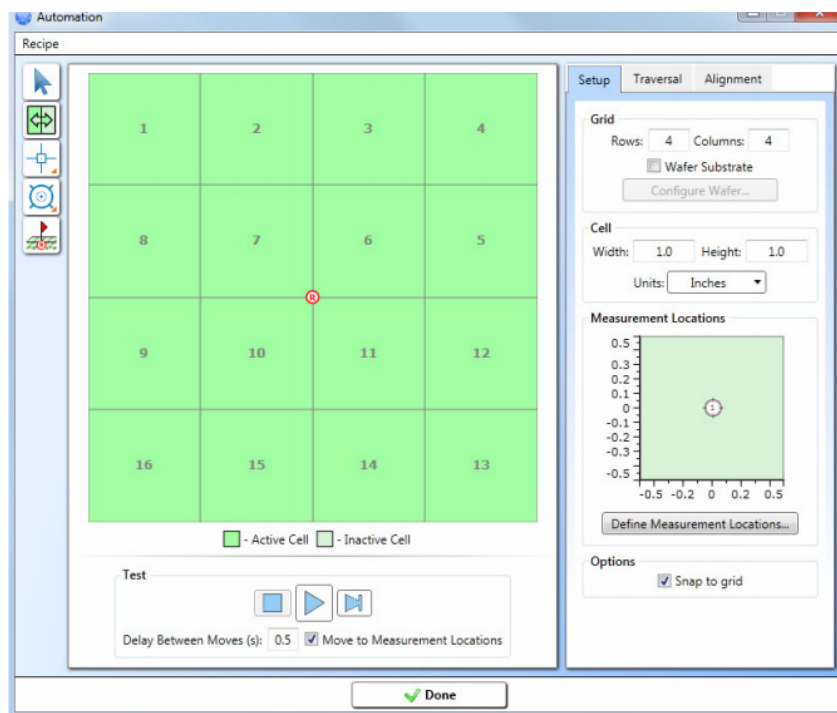


Figure 5-5: Automation Setup Vision View

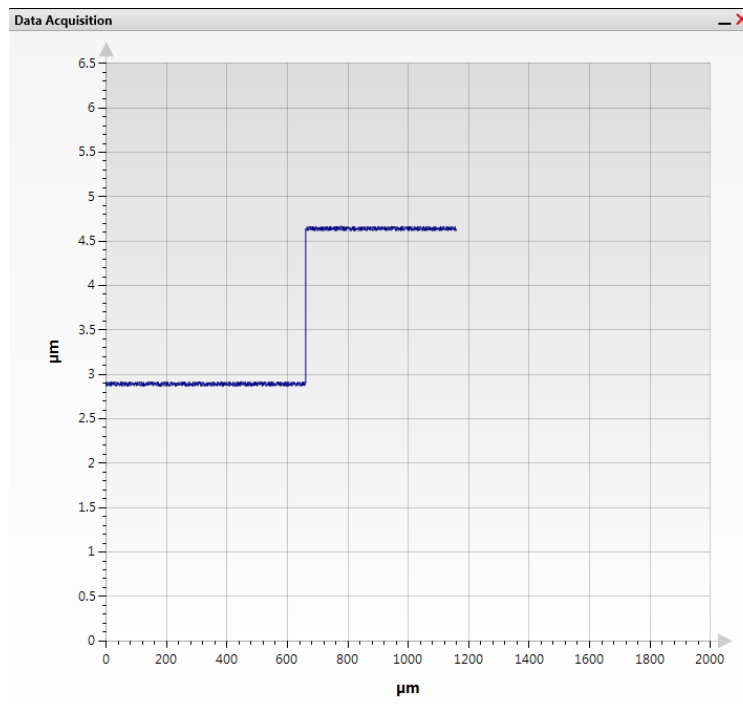


Figure 5-6: Data Acquisition Vision View

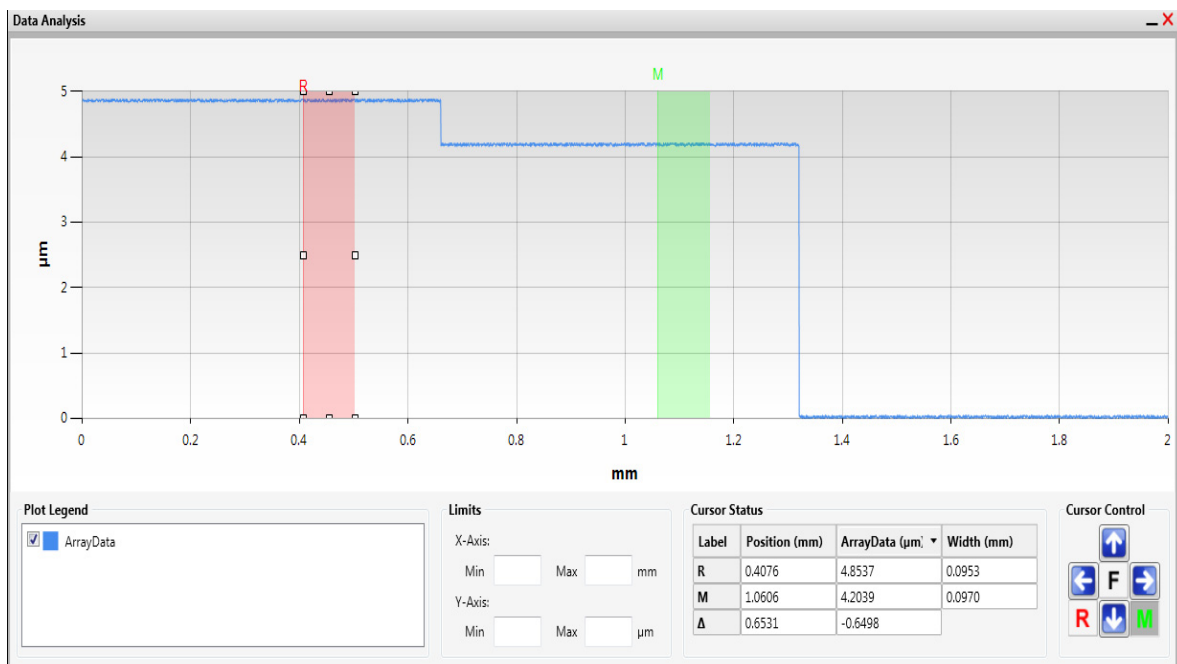


Figure 5-7: Data Analysis Vision View

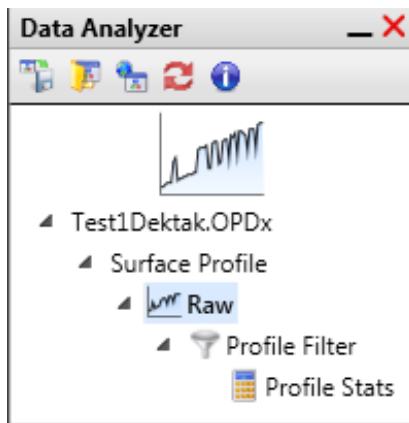


Figure 5-8: Data Analyzer

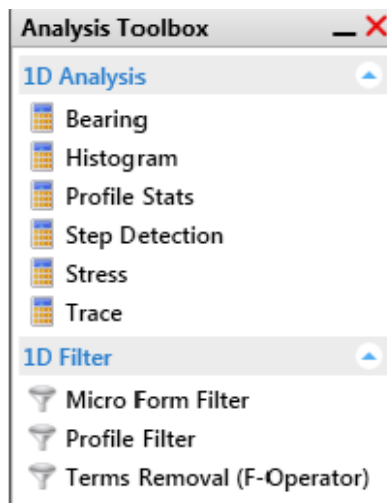


Figure 5-9: Analysis Toolbox

DISPLAYING OTHER VISION64 WINDOWS

In addition to the four Vision Views, you can display the following items:

- The Live Video Display that gives you a live view of your sample and the stylus (see [Figure 5-10](#)).
- The Instrument Control Panel that allows you to control the DektakXT profiler (see [Figure 5-11](#)).
- The Active Gallery Display that simultaneously displays thumbnail views of all active datasets. It appears below the Data Analysis Vision View (see [Figure 5-12](#)).
- The Database Display that shows statistical analysis results in a comma-separated variable file (see [Figure 5-13](#)).

NOTE – To use the Analysis toolbox: Click an icon to immediately apply it to the active dataset. Right-click an icon to open an analysis setup dialog box. The Analysis Toolbox is available only when Raw Data is selected in the Data Analyzer.

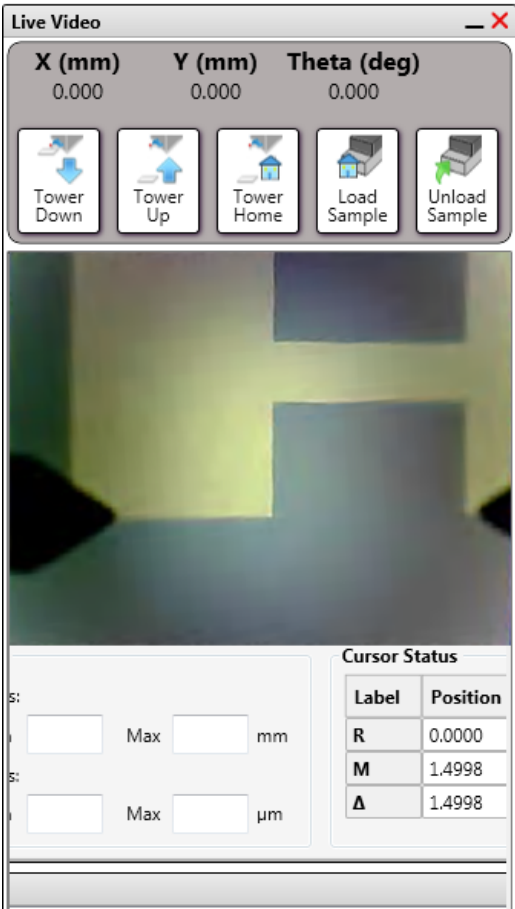


Figure 5-10: Live Video Display

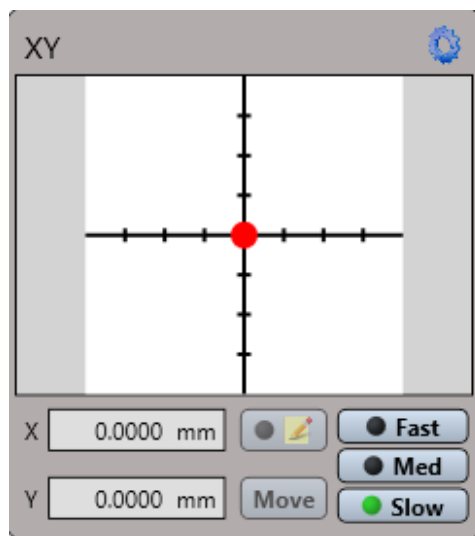
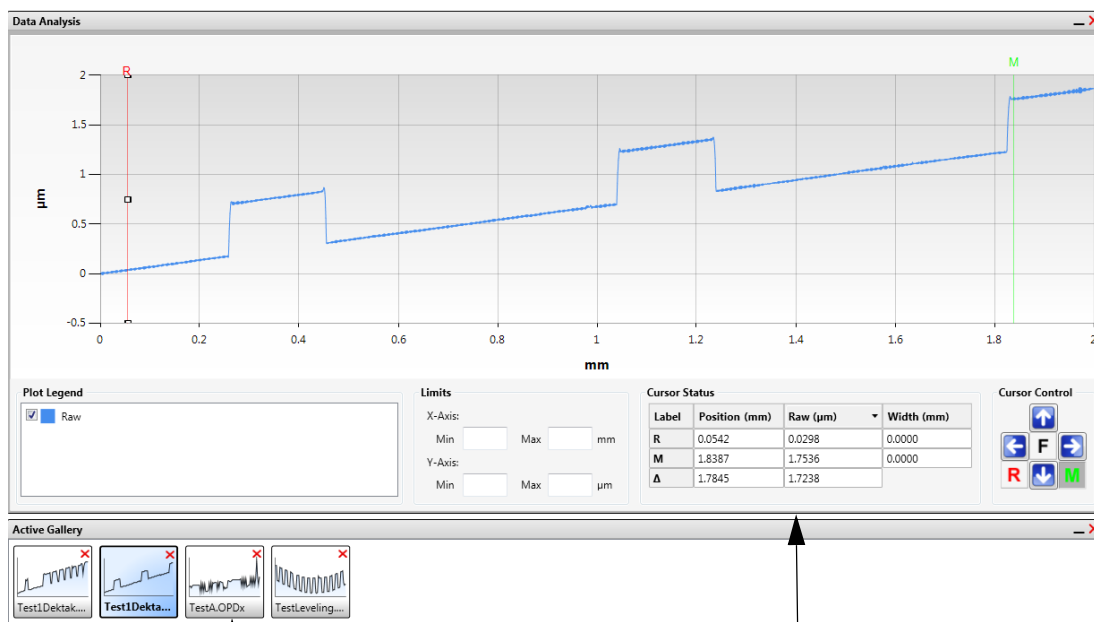


Figure 5-11: Instrument Control Panel for the X-Y Stage



Active Gallery showing four open datasets

Data Analysis Vision View showing the selected dataset

Figure 5-12: Active Gallery with Multiple Datasets

Database			
Measurement Number	Total_Pa μm R: 0 mm M: 49.9833 μm Always Always	Total_Pt μm R: 0 mm M: 49.9833 μm Always Always	Profil
1	0.02852	0.6589	
2	0.02737	0.5220	
3	0.02843	0.6687	
4	0.02453	0.6149	
Avg:	0.02721	0.6161	
Std:	0.00161	0.0580	
Skewness:	-0.90764	-0.7822	
Max:	0.02852	0.6687	
Min:	0.02453	0.5220	
Range:	0.00399	0.1467	
Pass:	4	4	
Fail:	0	0	

Figure 5-13: A DektakXT Database

MORE FEATURES OF THE INTERFACE

Application Menu Button Use this button  to open the Application Menu, from which you can access the most common Vision64 application functions (see [Figure 5-14](#)).

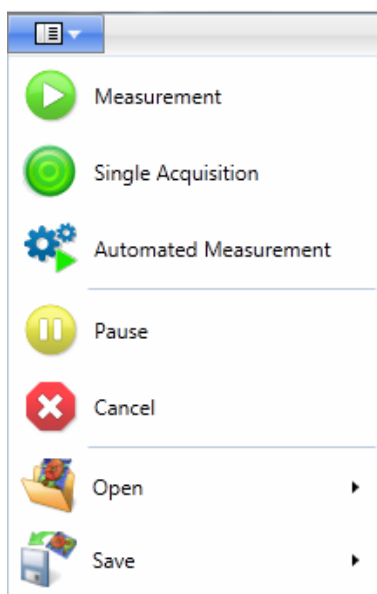


Figure 5-14: Application Menu

Ribbon This taskbar (see [Figure 5-15](#)) provides access to all of the functions available in Vision64. Note that the most commonly used buttons are permanently displayed to the left and right of each tab on the Ribbon.

Ribbon Tabs Click these tabs to make the Ribbon display the **Analyze** Tab (see [Figure 5-15](#)), the **Instrument** Tab, or the **Preferences** Tab. You can perform the functions on these tabs by clicking a button or by using keyboard shortcuts. Some tabs include split-buttons that provide multiple related commands.

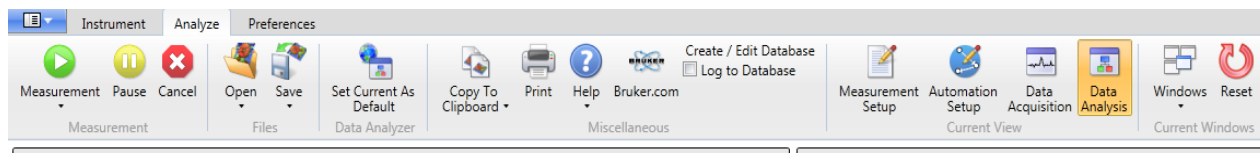


Figure 5-15: Ribbon with the Analyze Ribbon Tab Selected

CHANGING THE UNITS AND OTHER USER PREFERENCES

You can specify different units before or after a scan measurement. After you have done this, the data plot, scan parameters, measurement parameters, ranges, and analytical function calculations all appear in the new units that you have specified.

To change units before or after a scan measurement:

- 1 On the **Preferences** tab of the Ribbon, click the **Units and Numbers** button .
- 2 Make your settings in the **Units** dialog box (see [Figure 3-15](#)), and then click **OK**.

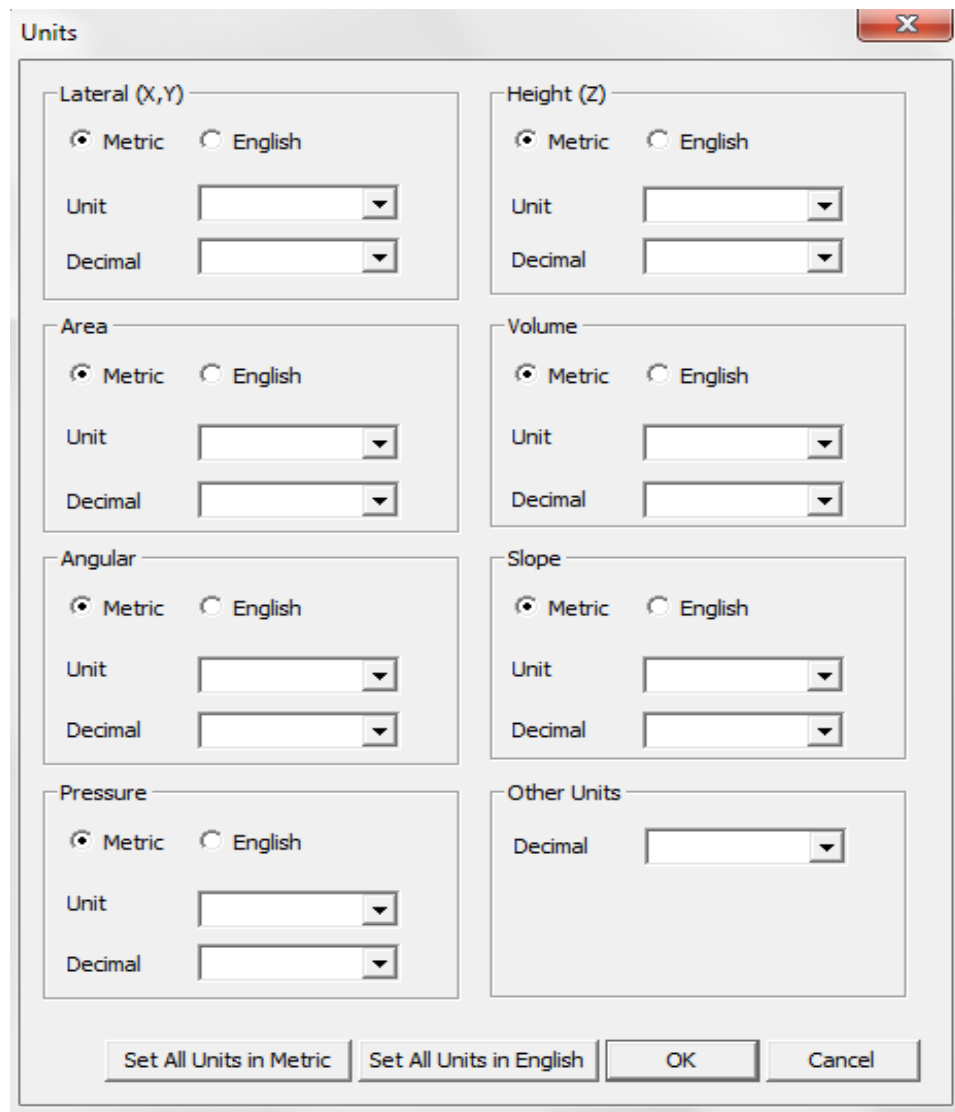


Figure 5-16: Units Dialog Box

APPLYING FILTERS

To apply a filter to the active dataset, click **Profile Filter** in the Data Analyzer (see [Figure 5-8](#)) or Analysis Toolbox (see [Figure 5-9](#)). Then click **Edit Settings** (in the Data Analyzer) or **Edit Default Settings** (in the Analysis Toolbox). The following dialog box appears.

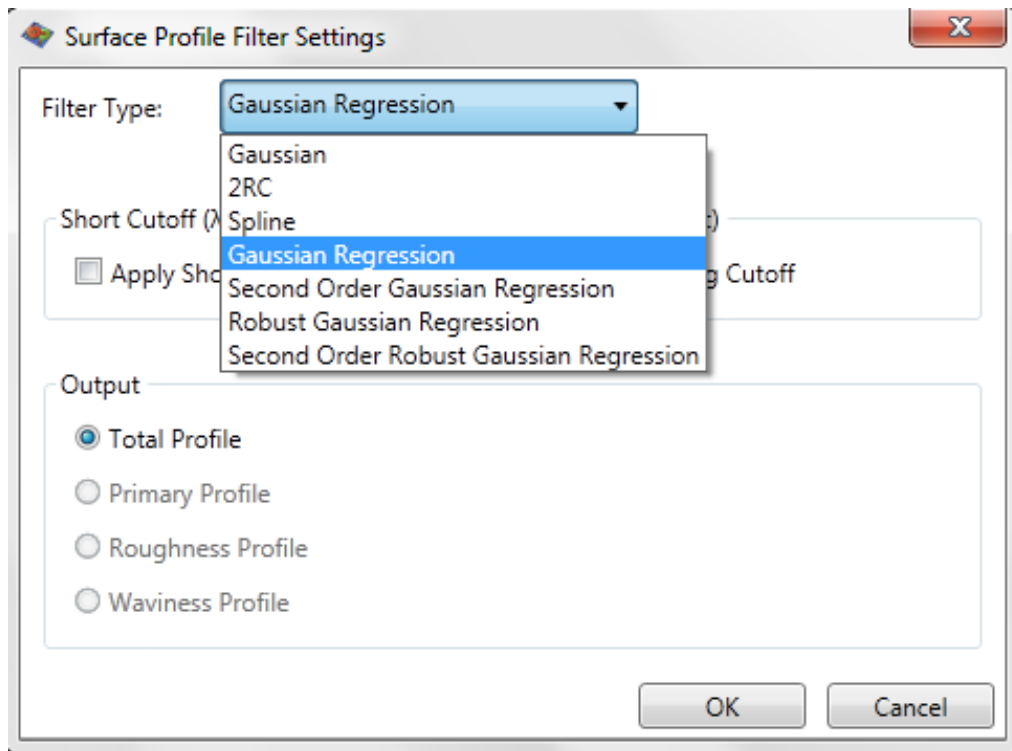


Figure 5-17: Surface Profile Filter Settings Dialog Box

Select the filter that you want to apply. If this is a Gaussian filter, select **Apply Short Cutoff** or **Apply Long Cutoff** to determine the frequency cutoff wavelength. In the **Output** section, select the type of profile in which you want to view the output. Click **OK**. The system applies the selected filter to the active dataset.

To apply a Terms Removal (F-Operator) or Micro Form filter, click it in the Analysis Toolbox (see [Figure 5-9](#)). To change the settings, right-click it prior to its application.

PERFORMING ANALYSES

To perform an analysis on the active dataset, click the analysis (for example, **Bearing Ratio**) that you want to apply in the Analysis Toolbox (see [Figure 5-9](#)). To change the analysis settings, right-click the analysis and select **Edit Default Settings** prior to performing it. Make your selections and click **OK**. The dialog box for the Bearing Ratio analysis appears in [Figure 5-18](#).

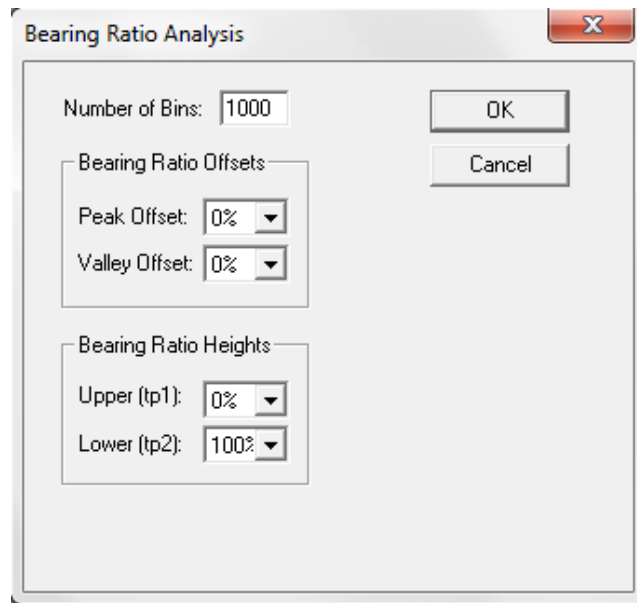


Figure 5-18: Bearing Ratio Analysis Dialog Box

3D MAPPING Option

If your Vision64 software includes the 3D Mapping Option, the user interface and workflow operate somewhat differently than described in this chapter. For example, the Data Visualization Taskbar allows you to quickly change the displayed plot while the Combo Plot drop-down list lets you select combination plots for display (see Figure 5-19). For more information about the 3D Mapping Option, see your Vision64 online Help.

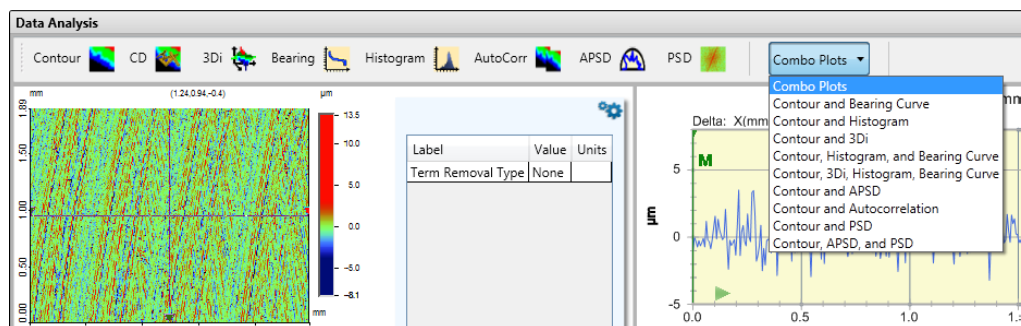


Figure 5-19: Data Visualization Taskbar and Combo Plot Drop-down List



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